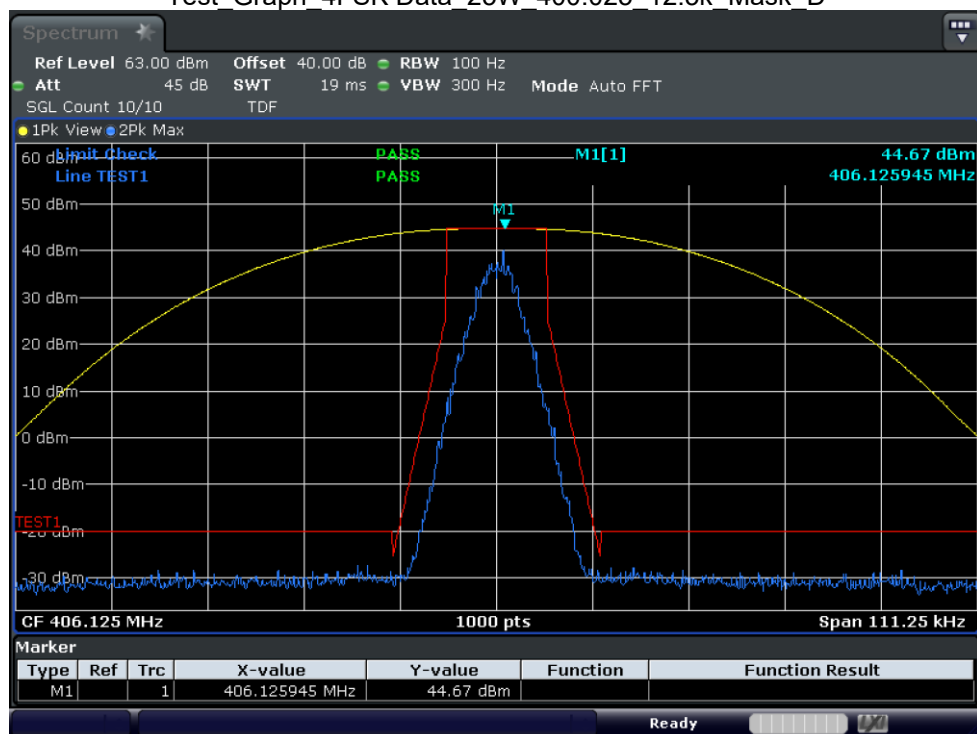
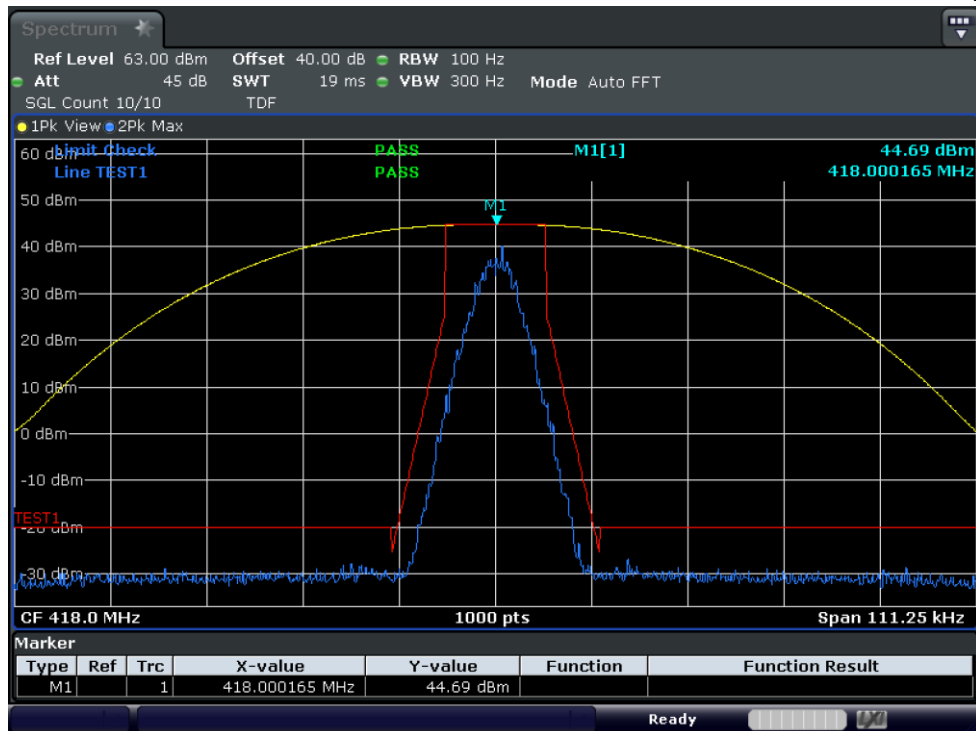


Test Graph 4FSK Data 25W 400.025 12.5k Mask D

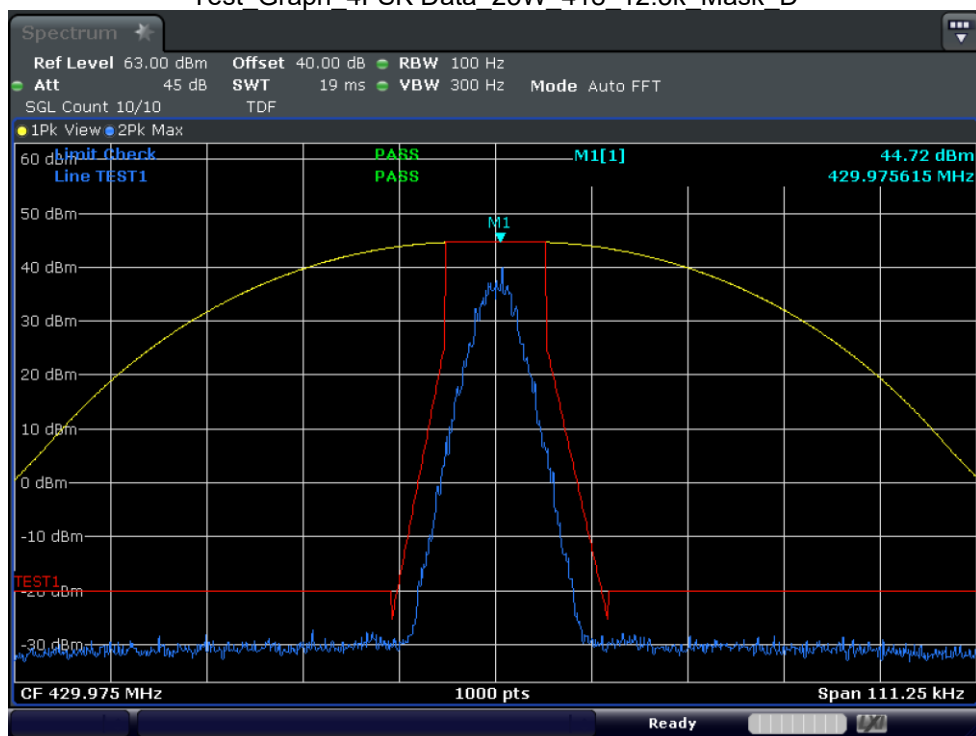


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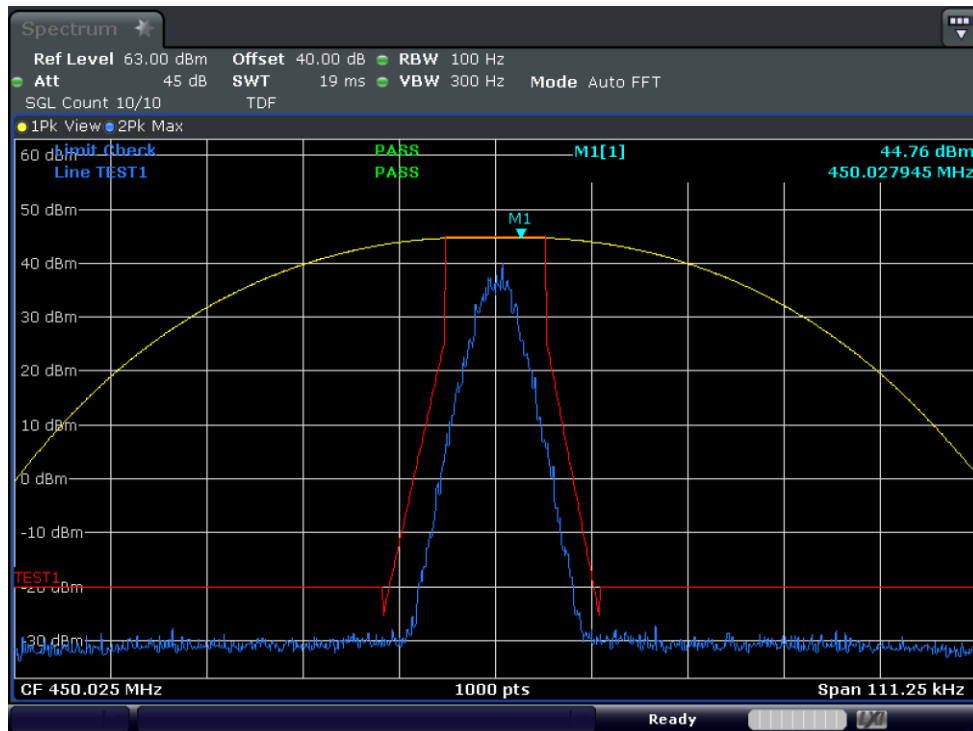


Test Graph 4FSK Data 25W 418 12.5k Mask D

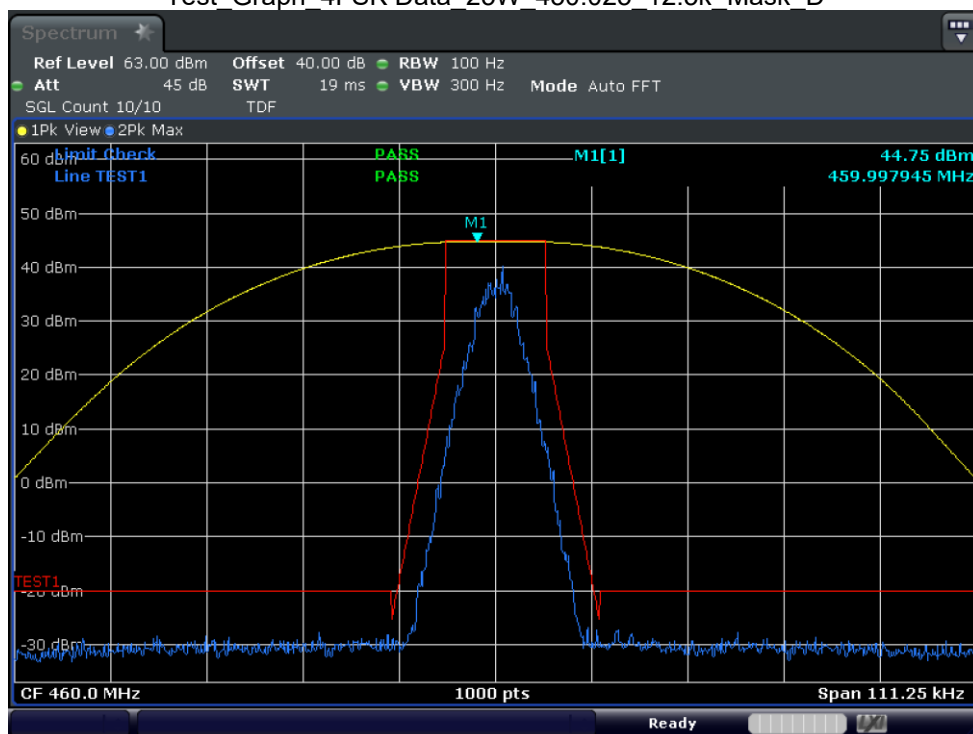


Test_Graph_4FSK Data_25W_429.975_12.5k_Mask_D



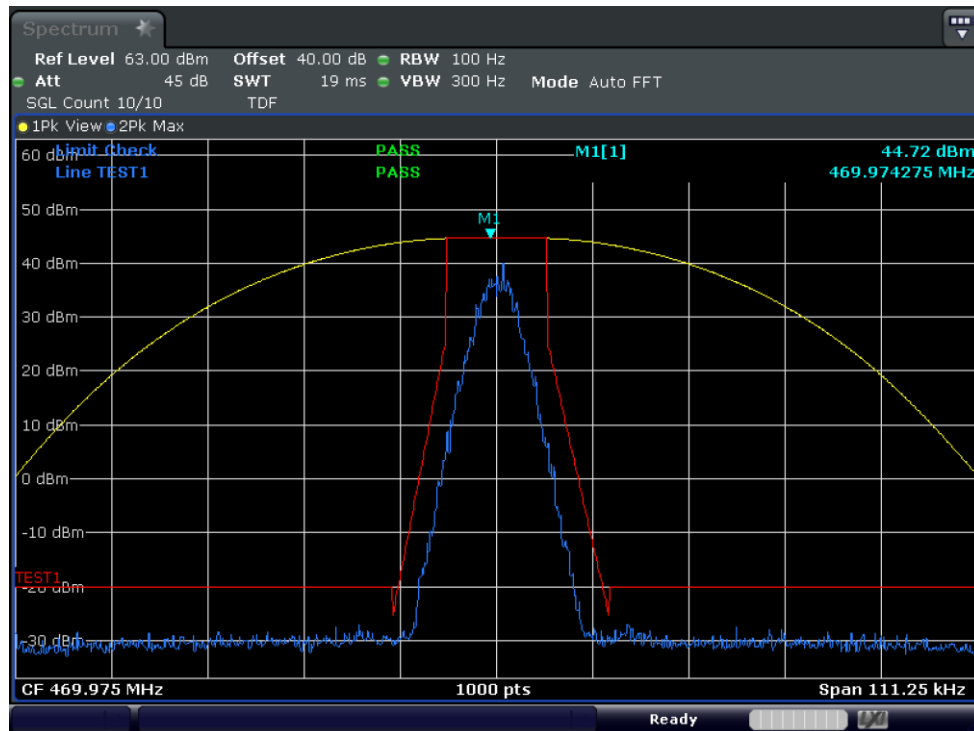


Test Graph 4FSK Data 25W 450.025 12.5k Mask D

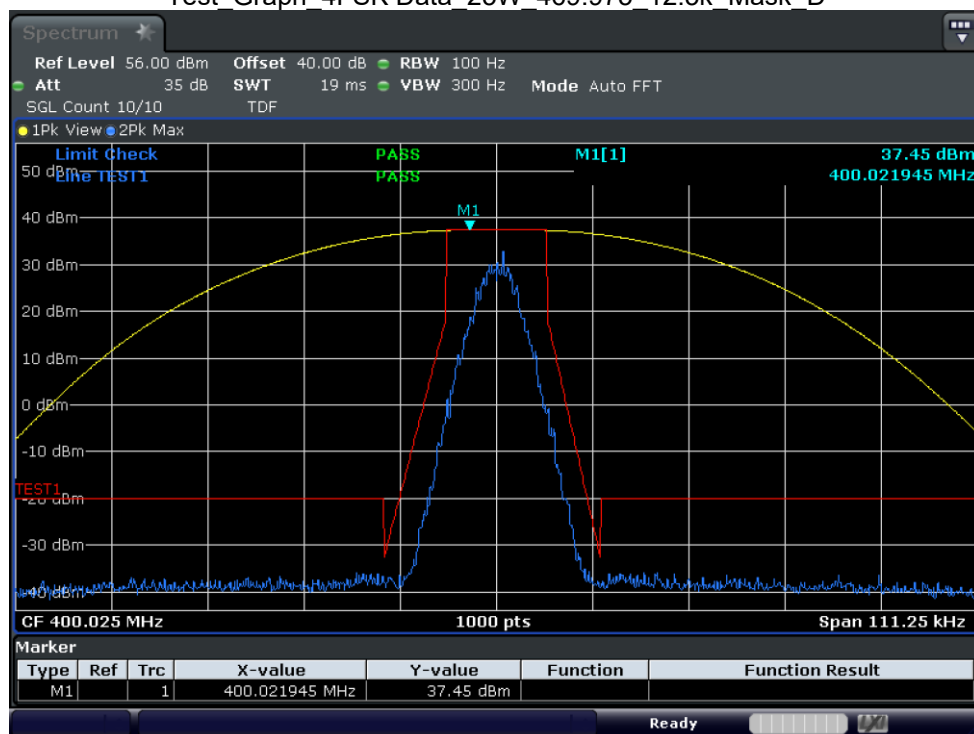


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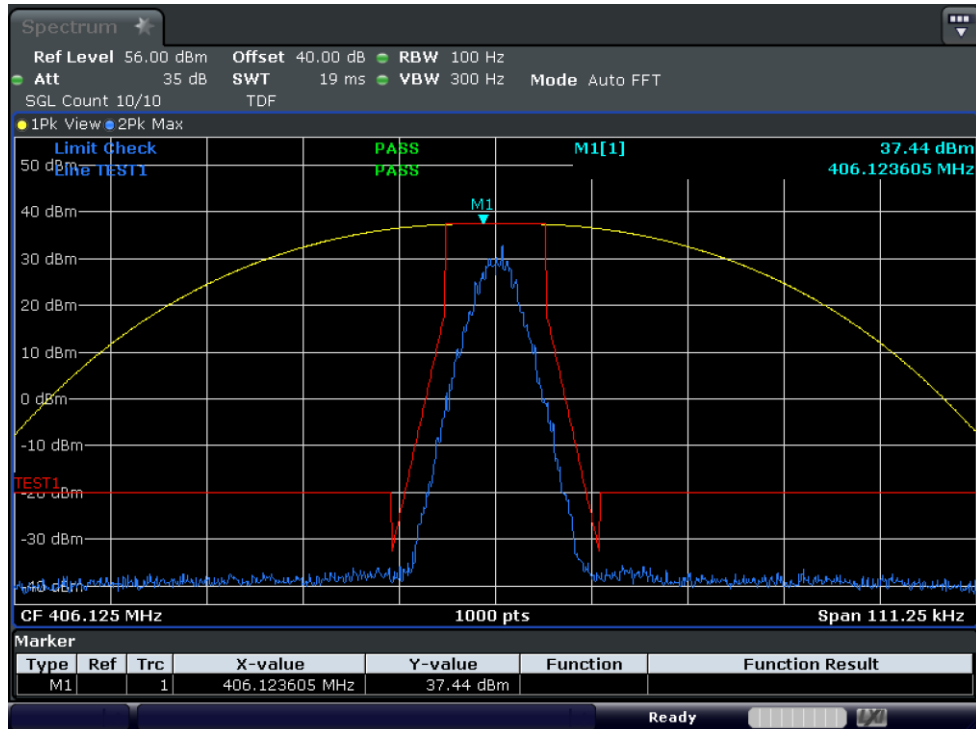


Test Graph 4FSK Data 25W 469.975 12.5k Mask D

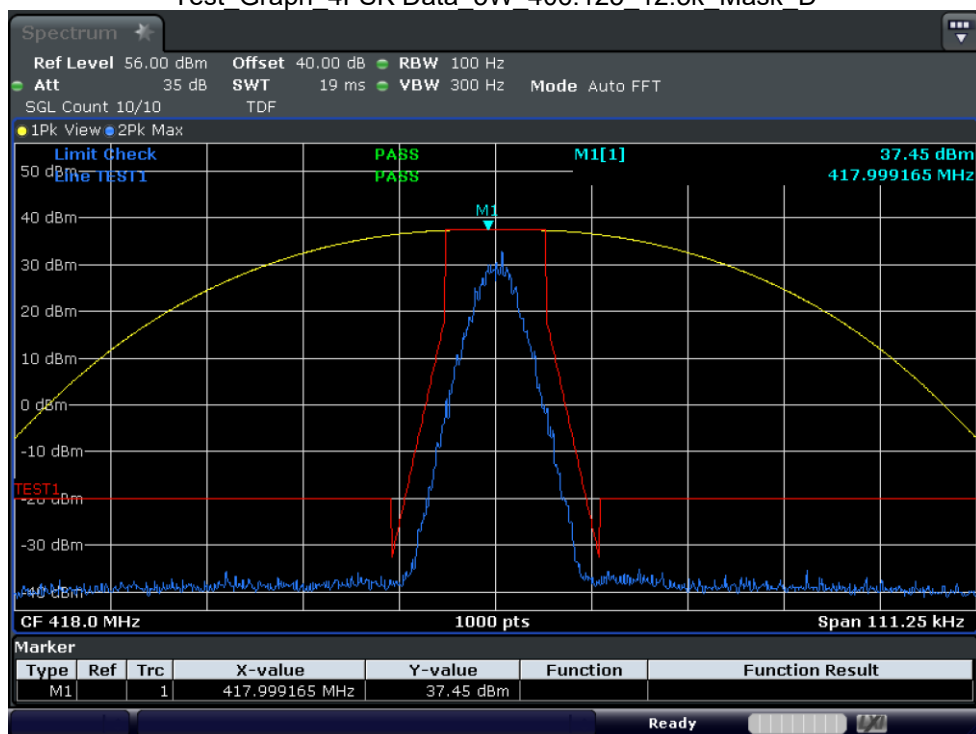


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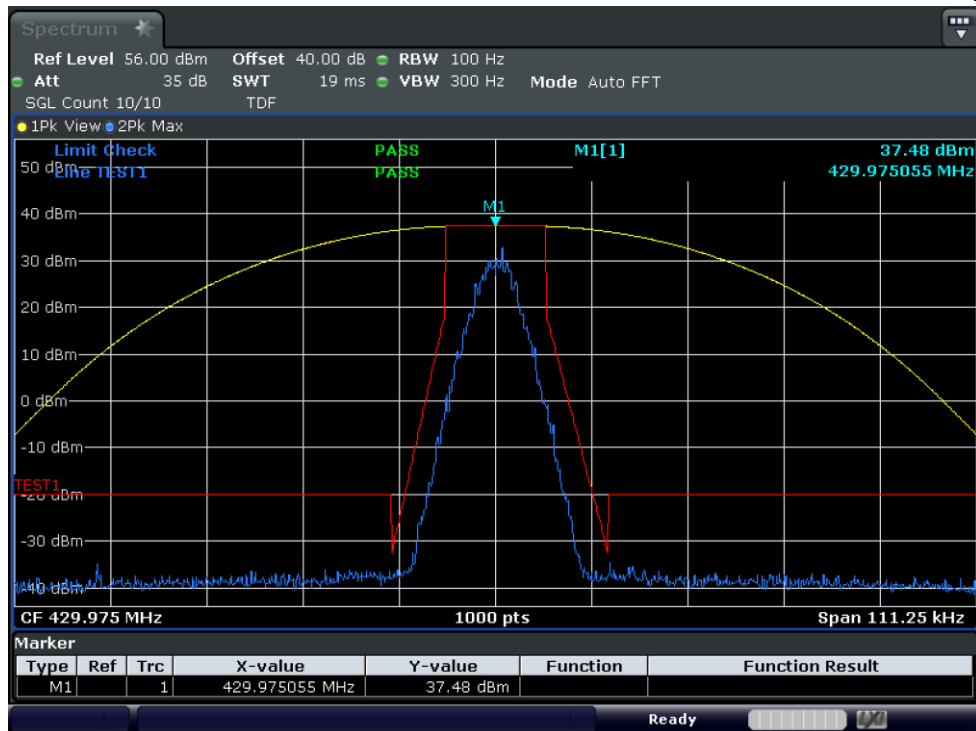


Test Graph 4FSK Data 5W 406.125 12.5k Mask D

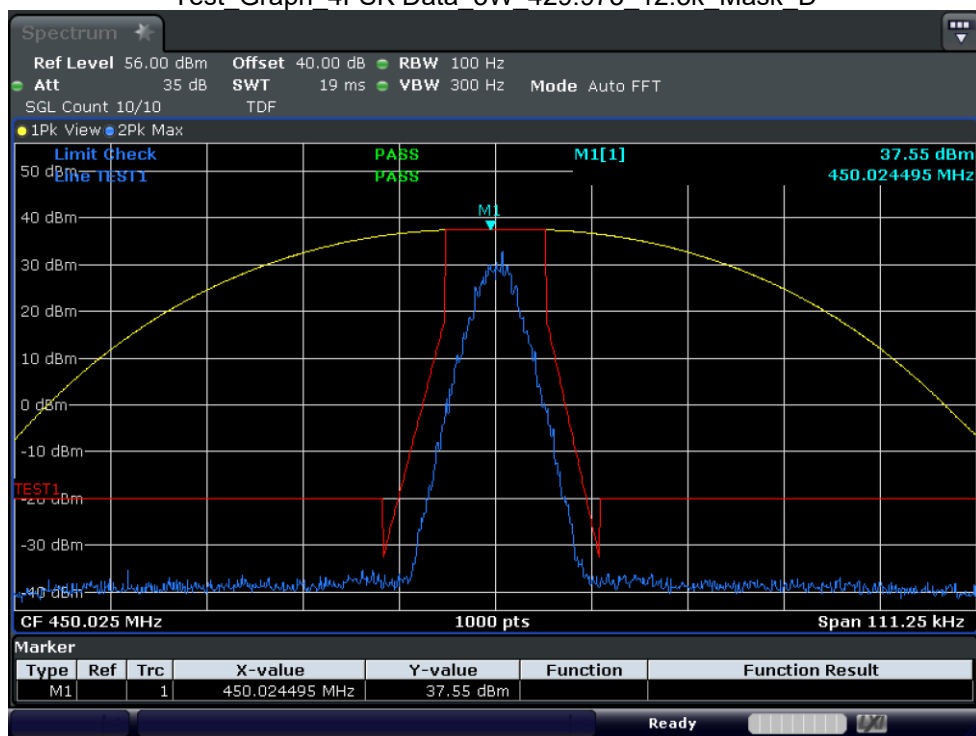


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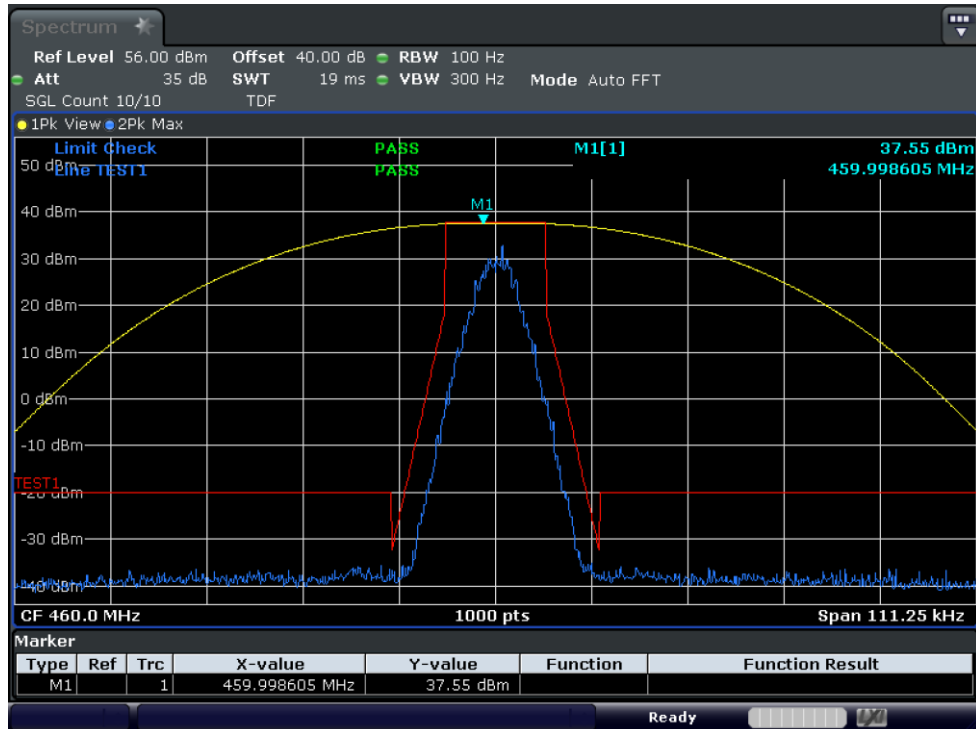


Test Graph 4FSK Data 5W 429.975 12.5k Mask D

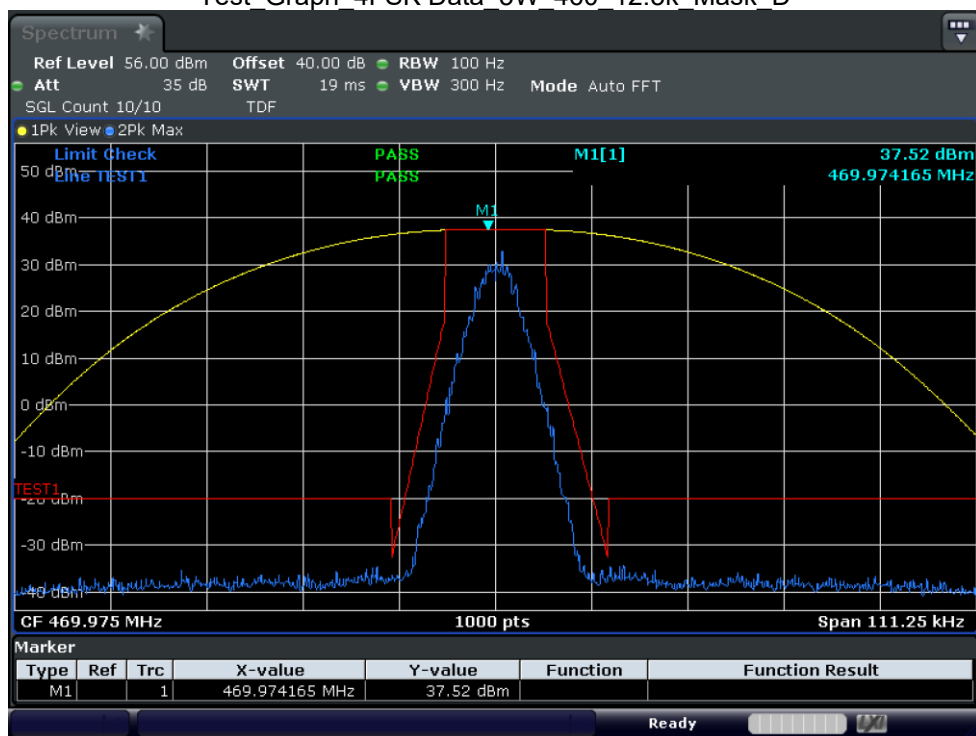


Test_Graph_4FSK Data_5W_450.025_12.5k_Mask_D





Test Graph 4FSK Data 5W 460 12.5k Mask D



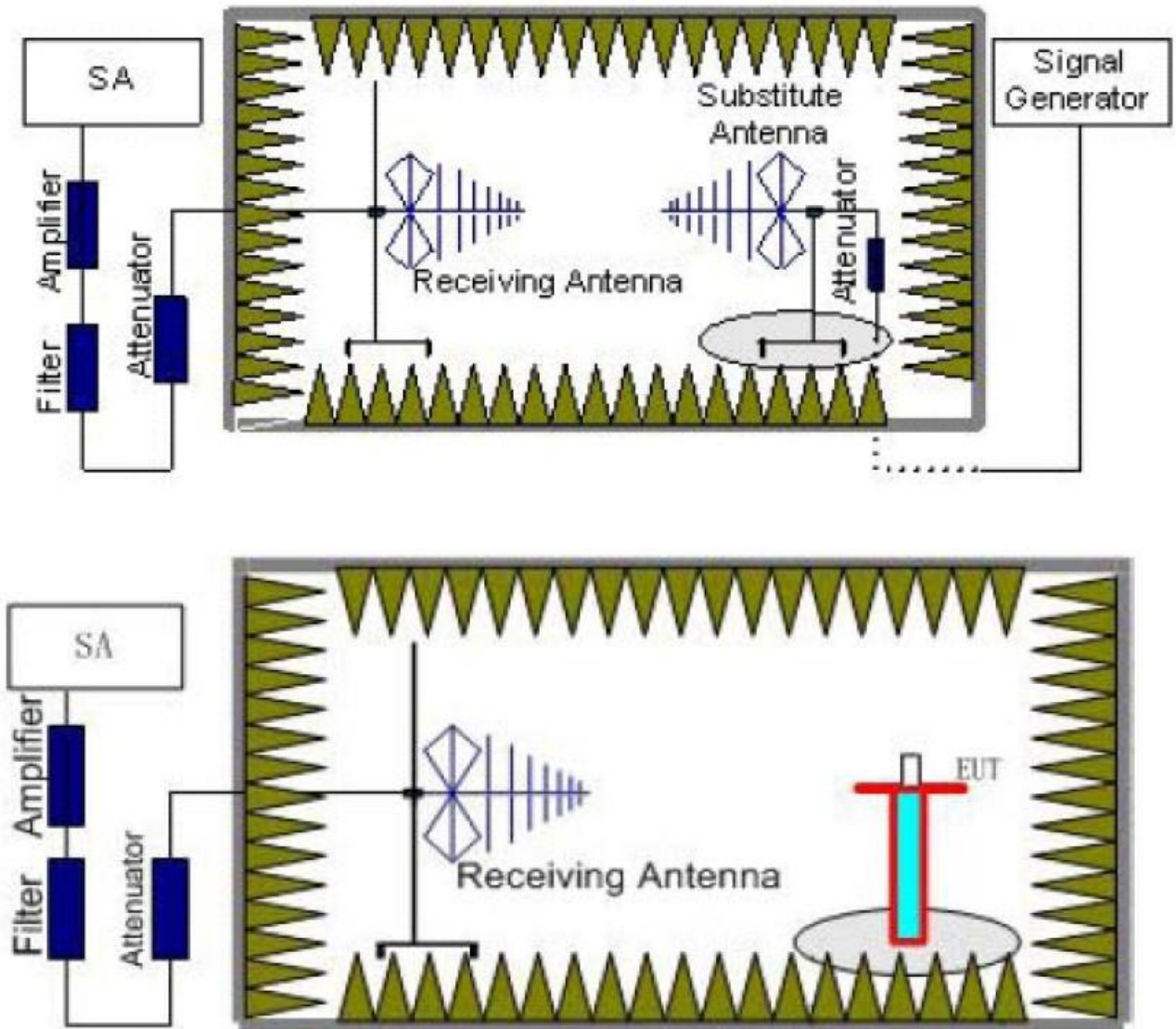
Test_Graph_4FSK Data_5W_469.975_12.5k_Mask_D





4.4. Field Strength Spurious Emissions

TEST CONFIGURATION





TEST PROCEDURE

1. EUT was placed on a 1.50 meter high non-conductive stand at a 3 meter test distance from the receive antenna. A receiving antenna was placed on the antenna mast 3 meters from the EUT for emission measurements. The height of receiving antenna is 1.50 m. Detected emissions were maximized at each frequency by rotating the EUT through 360° and adjusting the receiving antenna polarization. The radiated emission measurements of all transmit frequencies in six channels were measured with peak detector.
2. A log-periodic antenna or double-ridged waveguide horn antenna shall be substituted in place of the EUT. The log-periodic antenna will be driven by a signal generator and the level will be adjusted till the same power value on the spectrum analyser or receiver. The level of the spurious emissions can be calculated through the level of the signal generator, cable loss, the gain of the substitution antenna and the reading of the spectrum analyser or receiver.
3. The EUT is then put into continuously transmitting mode at its maximum power level during the test. Set Test Receiver or Spectrum RBW=1MHz,VBW=3MHz for above 1GHz and RBW=100KHz,VBW=300KHz for 30MHz to 1GHz, And the maximum value of the receiver should be recorded as (P_r).
4. The EUT shall be replaced by a substitution antenna. In the chamber, an substitution antenna for the frequency band of interest is placed at the reference point of the chamber. An RF Signal source for the frequency band of interest is connected to the substitution antenna with a cable that has been constructed to not interfere with the radiation pattern of the antenna. A power (P_{Mea}) is applied to the input of the substitution antenna, and adjust the level of the signal generator output until the value of the receiver reach the previously recorded (P_r). The power of signal source (P_{Mea}) is recorded. The test should be performed by rotating the test item and adjusting the receiving antenna polarization.
5. A amplifier should be connected to the Signal Source output port. And the cable should be connect between the Amplifier and the Substitution Antenna. The cable loss (P_{cl}), the Substitution Antenna Gain (G_a) and the Amplifier Gain (P_{Ag}) should be recorded after test.
The measurement results are obtained as described below:

$$\text{Power(EIRP)} = P_{Mea} - P_{Ag} - P_{cl} + G_a$$

It can omit power amplifier if signal generator level meets requirement;

This value is EIRP since the measurement is calibrated using an antenna of known gain (2.15 dBi) and known input power.

6. ERP can be calculated from EIRP by subtracting the gain of the dipole, $ERP = EIRP - 2.15\text{dBi}$.

Subrange (GHz)	RBW	VBW	Sweep time (s)
0.00009~0.15	1KHz	3KHz	30
0.00015~0.03	10KHz	30KHz	10
0.03~1	100KHz	300KHz	10
1~5	1 MHz	3 MHz	5

TEST LIMIT

According to §90.210 d) (3) On any frequency removed from the center of the authorized bandwidth by a displacement frequency (f_d in kHz) of more than 12.5 kHz: At least $50 + 10 \log(P)$ dB or 70 dB, whichever is the lesser attenuation.

According to §90.210 b) (3) On any frequency removed from the assigned frequency by more than 250 percent of the authorized bandwidth: At least $43 + 10 \log(P)$ dB.

TEST RESULTS

1. In general, the worst case attenuation requirement shown above was applied.
2. The measurement frequency range from 9KHz to 5 GHz.





3. EIRP for measure frequency above 1 GHz and ERP for below 1 GHz.

4. *** means that the emission level is too low to be measured or at least 20 dB down than the limit.

Test Frequency: 400.025MHz				Channel Separation:12.5KHz			
Frequency (MHz)	P _{Mea} (dBm)	Path Loss	Antenna Gain	Correction (dB)	Values (dBm)	Limit (dBm)	Polarization
800.05	-44.16	0.61	7.31	2.15	-39.61	-20	H
1,200.08	-45.67	0.88	7.73	0	-38.82	-20	H
1,600.10	-50.24	1.2	8.16	0	-43.28	-20	H
...	H
800.05	-42.57	0.61	7.31	2.15	-38.02	-20	V
1,200.08	-45.08	0.88	7.73	0	-38.23	-20	V
1,600.10	-51.11	1.2	8.16	0	-44.15	-20	V
...	V

Test Frequency: 469.975MHz				Channel Separation:12.5KHz			
Frequency (MHz)	P _{Mea} (dBm)	Path Loss	Antenna Gain	Correction (dB)	Values (dBm)	Limit (dBm)	Polarization
939.95	-44.01	0.72	7.52	2.15	-39.36	-20	H
1,409.93	-46.12	1.12	8.06	0	-39.18	-20	H
1,879.90	-48.79	1.55	8.6	0	-41.74	-20	H
...	H
939.95	-43.75	0.72	7.52	2.15	-39.1	-20	V
1,409.93	-46.99	1.12	8.06	0	-40.05	-20	V
1,879.90	-50.08	1.55	8.6	0	-43.03	-20	V
...	V

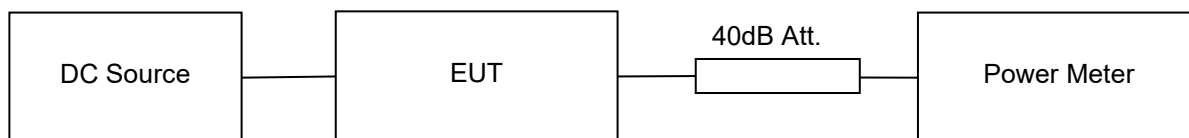
Note: All the test modes was tested, but only the worst mode(25W power level at lowest frequency and highest frequency) be recorded in this part.





4.5. Conducted spurious emission result(at antenna terminal):

TEST CONFIGURATION



TEST PROCEDURE

- 1) Connect the equipment as illustrated.
- 2) Set EUT working in continuous mode in low, middle, high frequency, read and record the peak power value.

TEST LIMIT

According to §90.210 d) (3) On any frequency removed from the center of the authorized bandwidth by a displacement frequency (f_d in kHz) of more than 12.5 kHz: At least $50 + 10 \log(P)$ dB or 70 dB, whichever is the lesser attenuation.

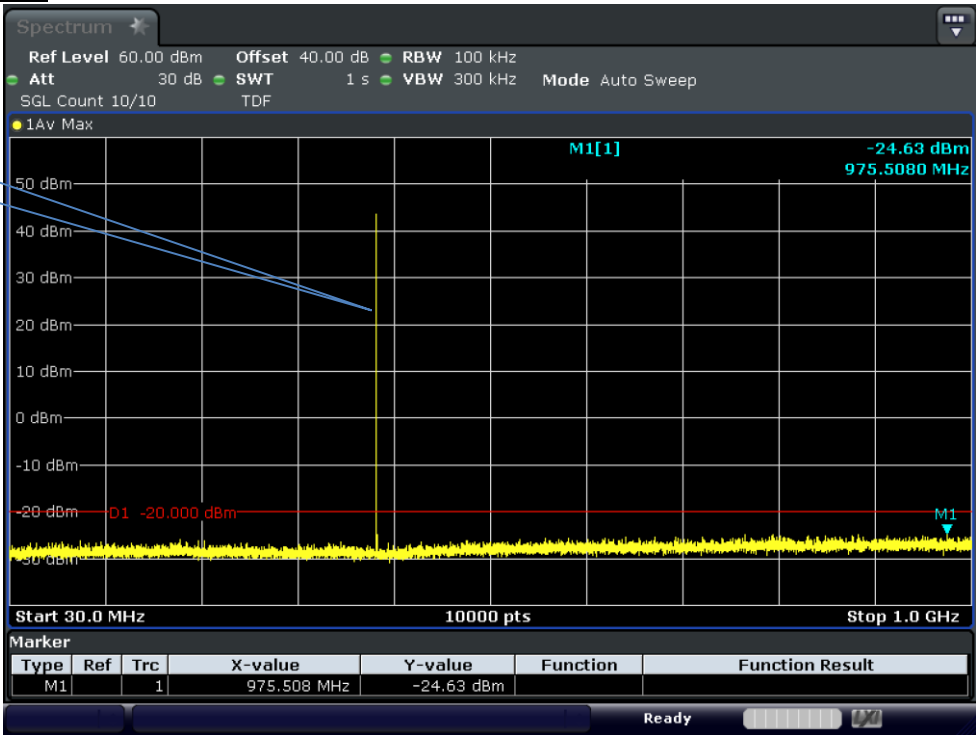
According to §90.210 b) (3) On any frequency removed from the assigned frequency by more than 250 percent of the authorized bandwidth: At least $43 + 10 \log(P)$ dB.



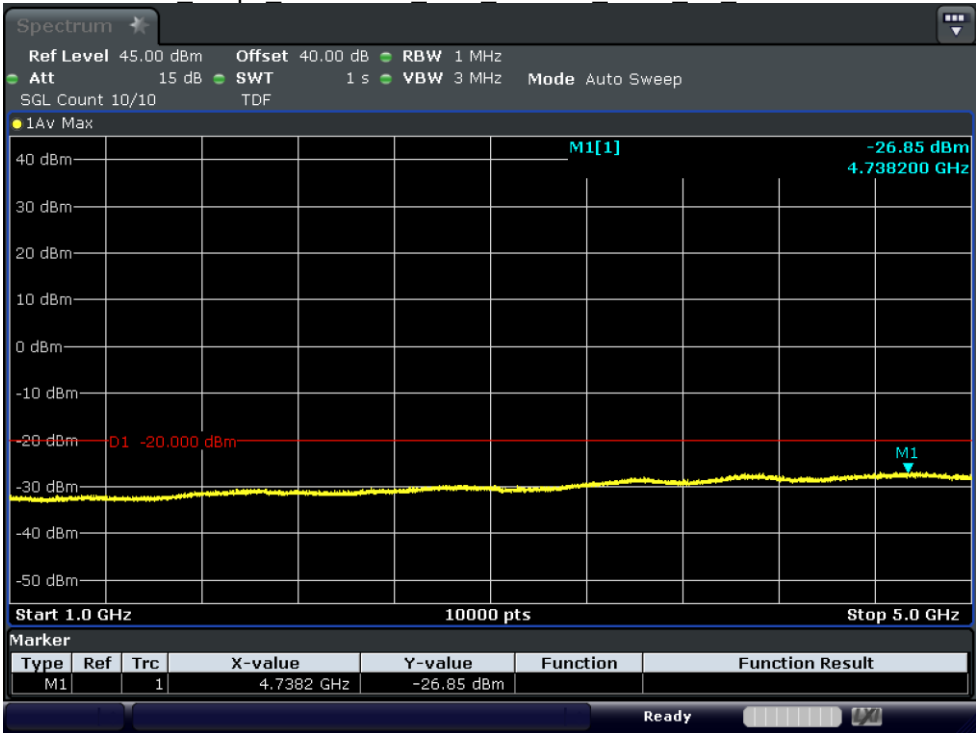


TEST RESULTS

Fundamental



Test Graph 4FSK Data 25W 400.025 12.5k TX 0.03G-1G

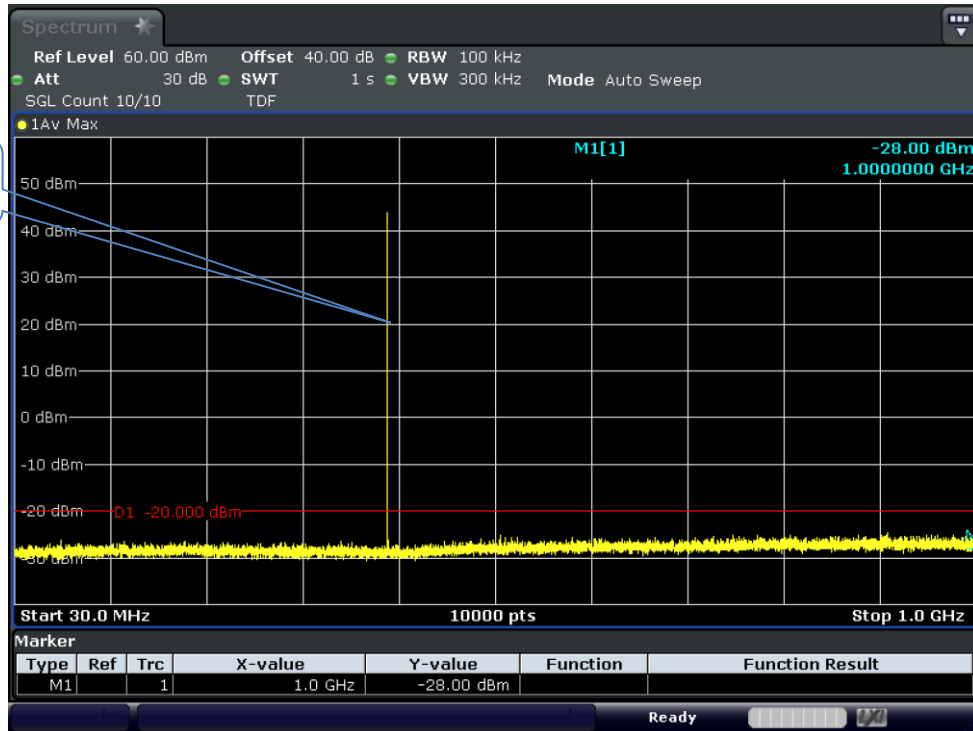


Test_Graph_4FSK Data_25W_400.025_12.5k_TX_1G-5G

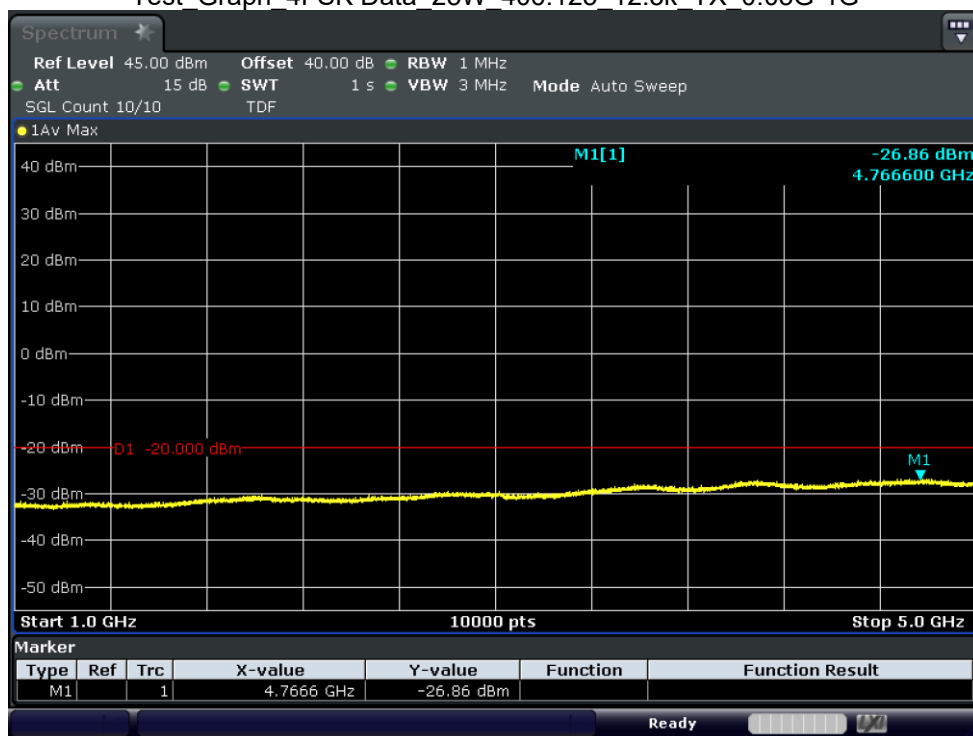




Fundamental



Test Graph 4FSK Data 25W 406.125 12.5k TX 0.03G-1G

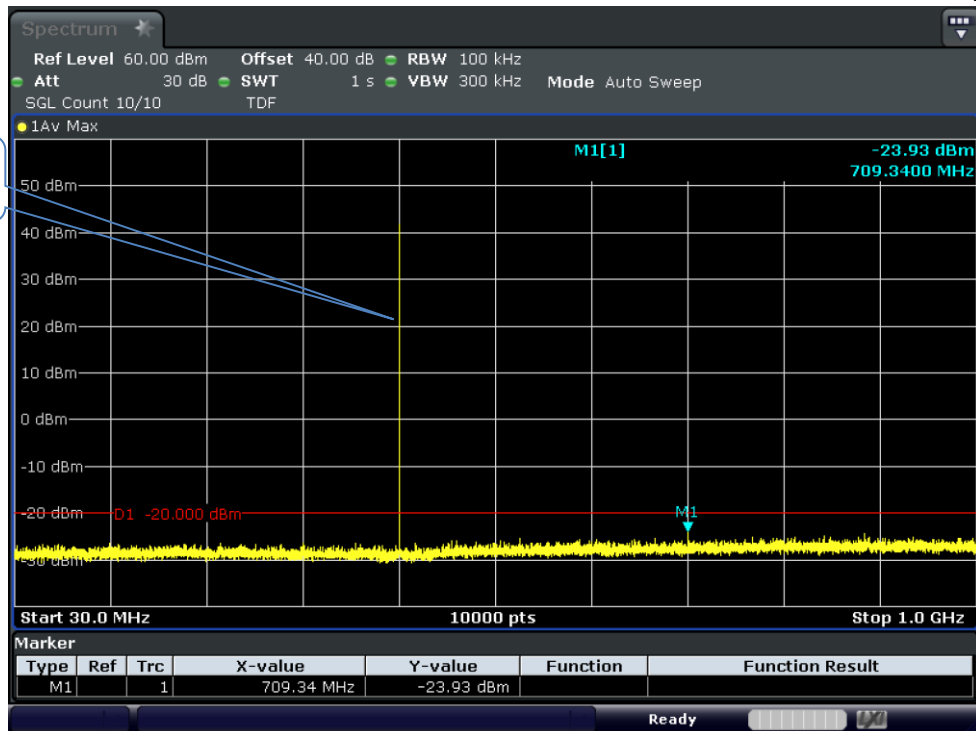


Test_Graph_4FSK Data_25W_406.125_12.5k_TX_1G-5G

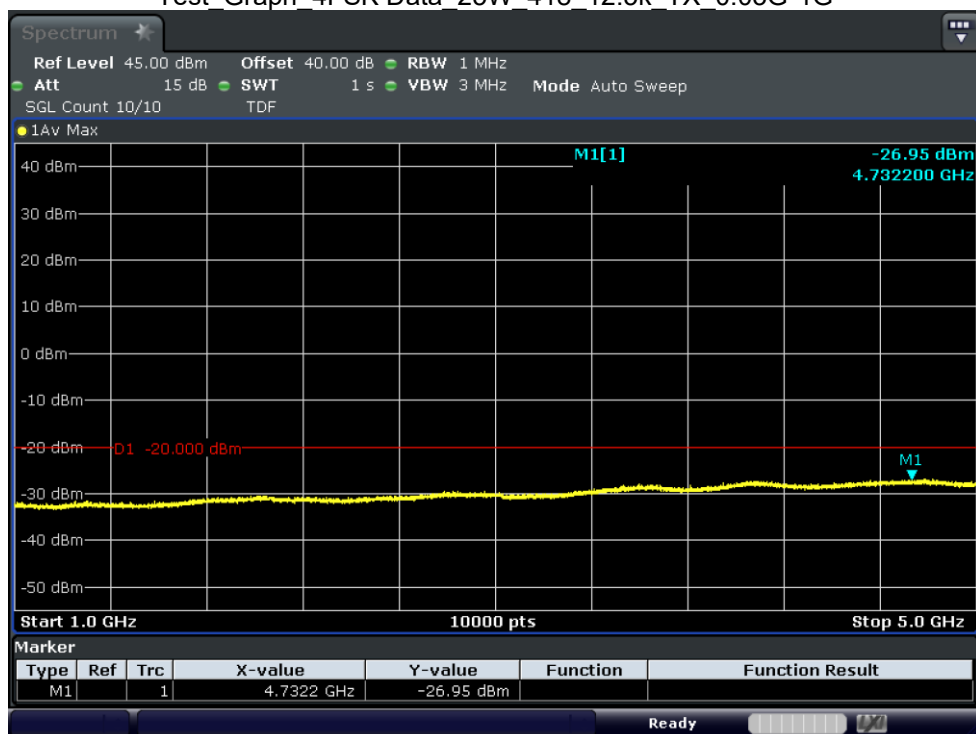




Fundamental



Test Graph 4FSK Data 25W 418 12.5k TX 0.03G-1G

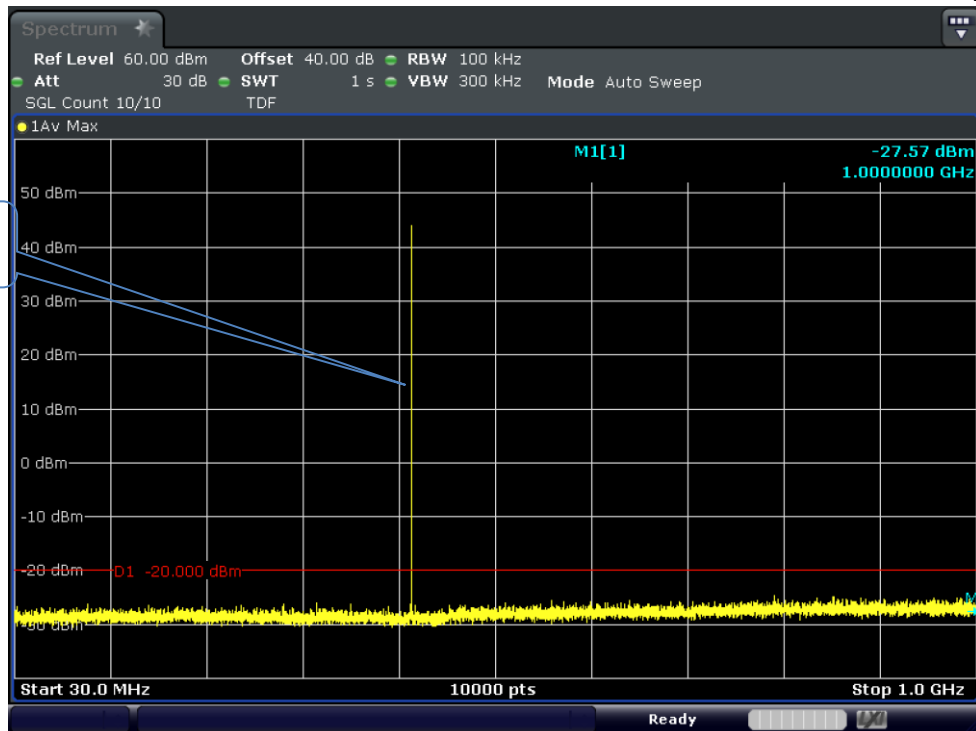


Test_Graph_4FSK Data_25W_418_12.5k_TX_1G-5G

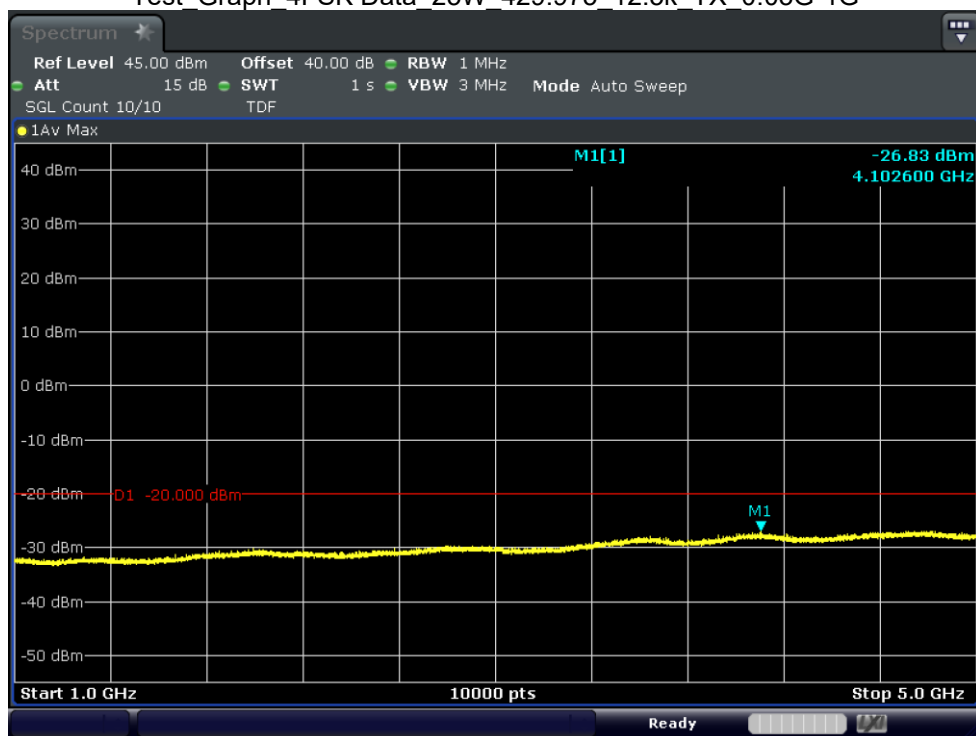




Fundamental



Test Graph 4FSK Data 25W 429.975 12.5k TX 0.03G-1G

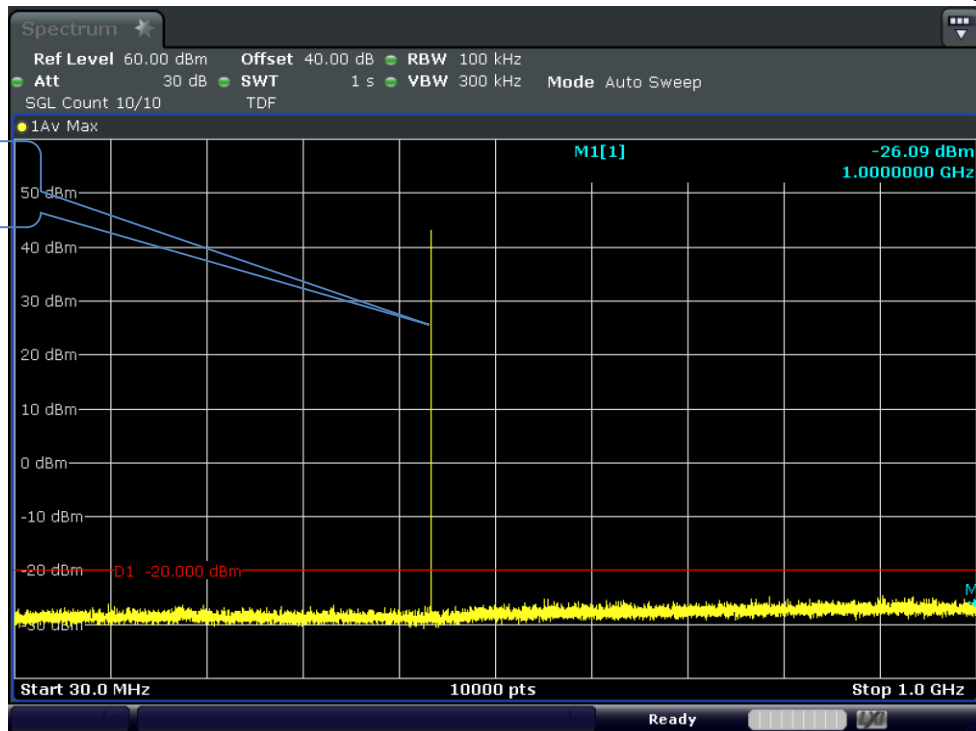


Test_Graph_4FSK Data_25W_429.975_12.5k_TX_1G-5G

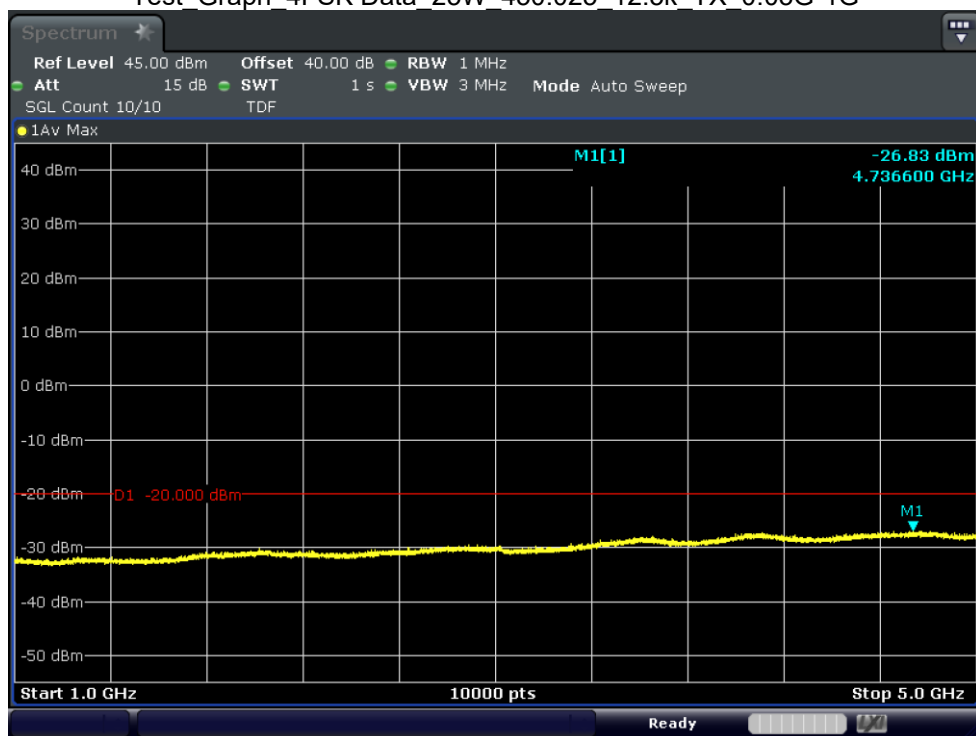




Fundamental

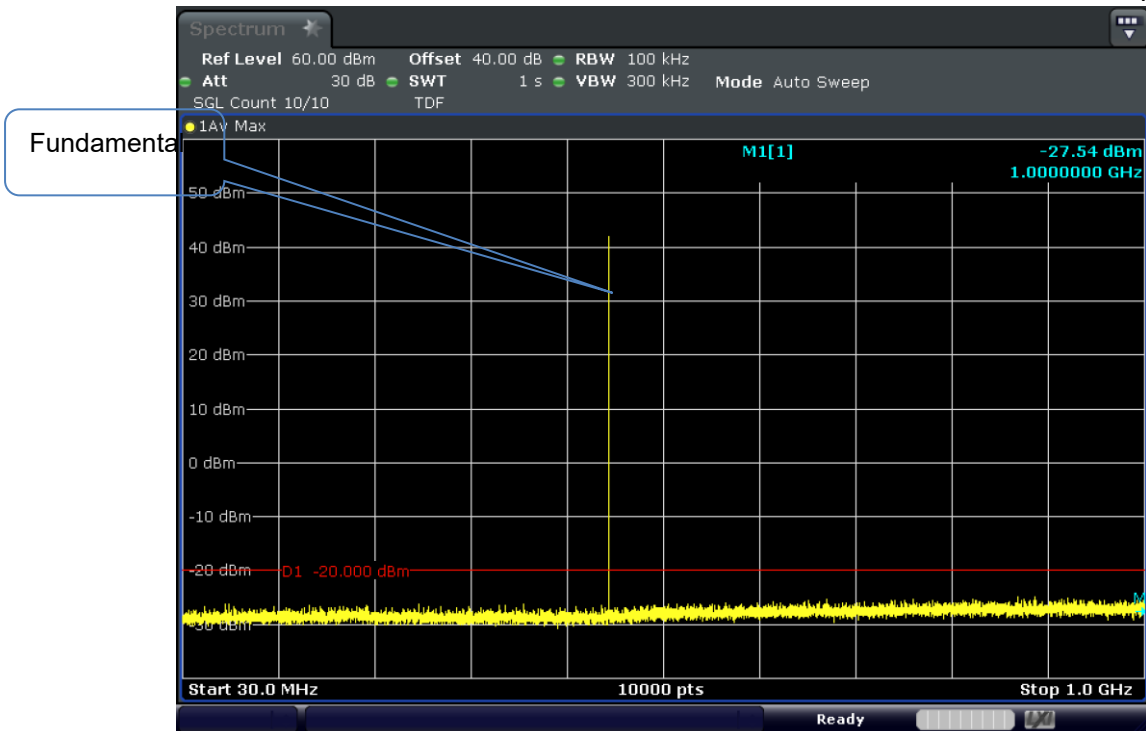


Test Graph 4FSK Data 25W 450.025 12.5k TX 0.03G-1G

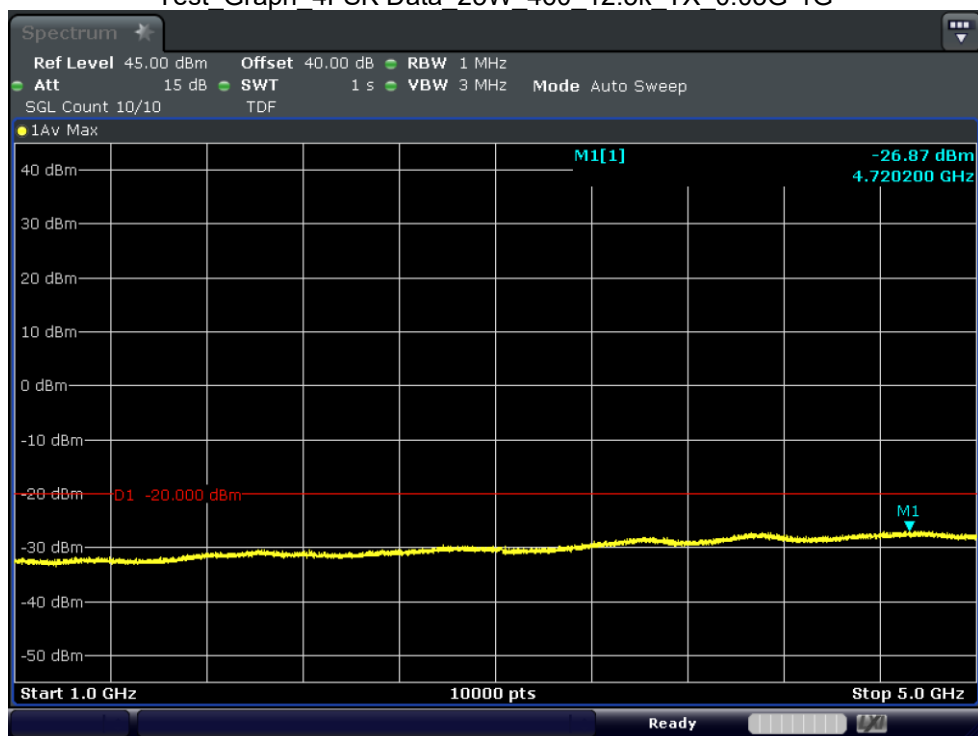


Test_Graph_4FSK Data_25W_450.025_12.5k_TX_1G-5G



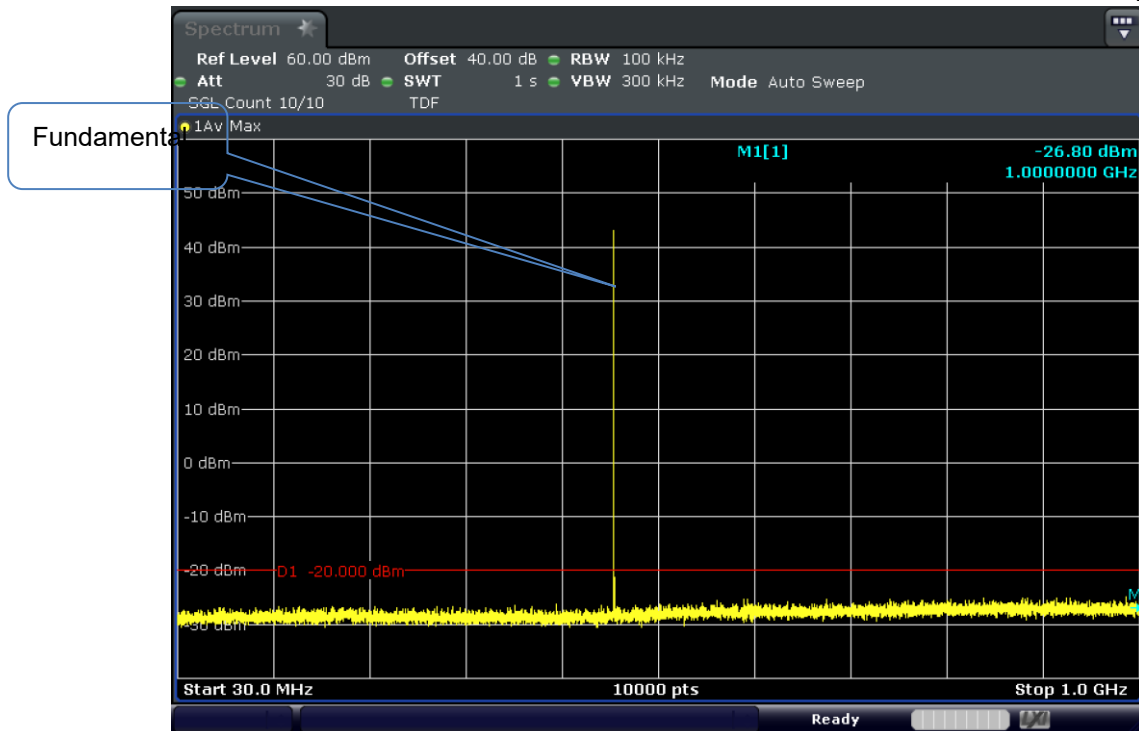


Test Graph 4FSK Data 25W 460 12.5k TX 0.03G-1G

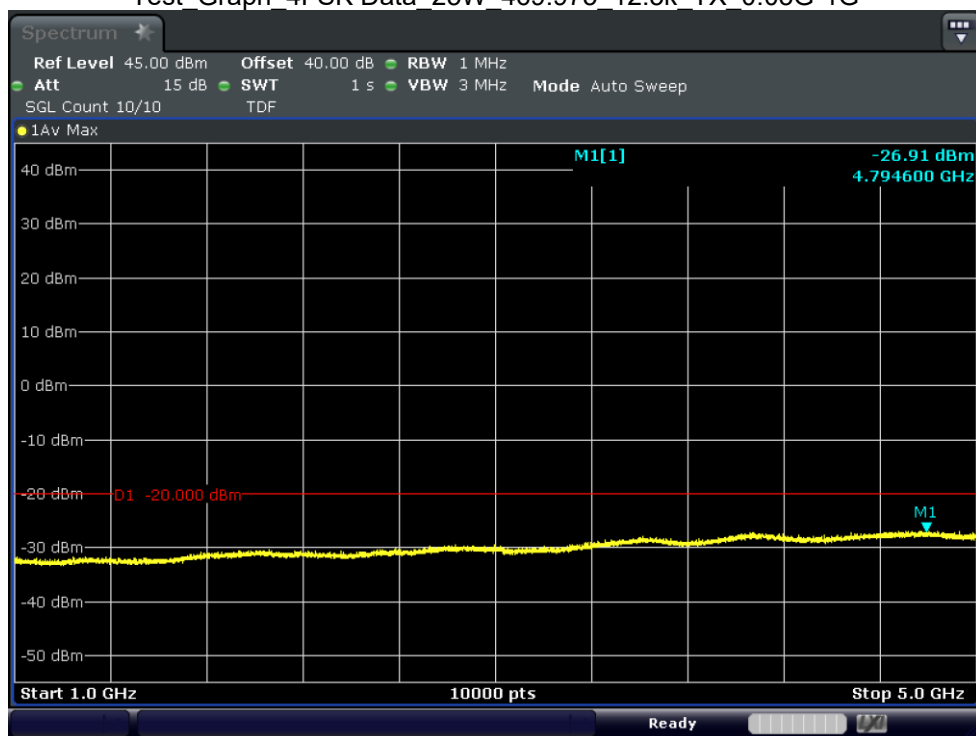


Test_Graph_4FSK Data_25W_460_12.5k_TX_1G-5G





Test Graph 4FSK Data 25W 469.975 12.5k TX 0.03G-1G

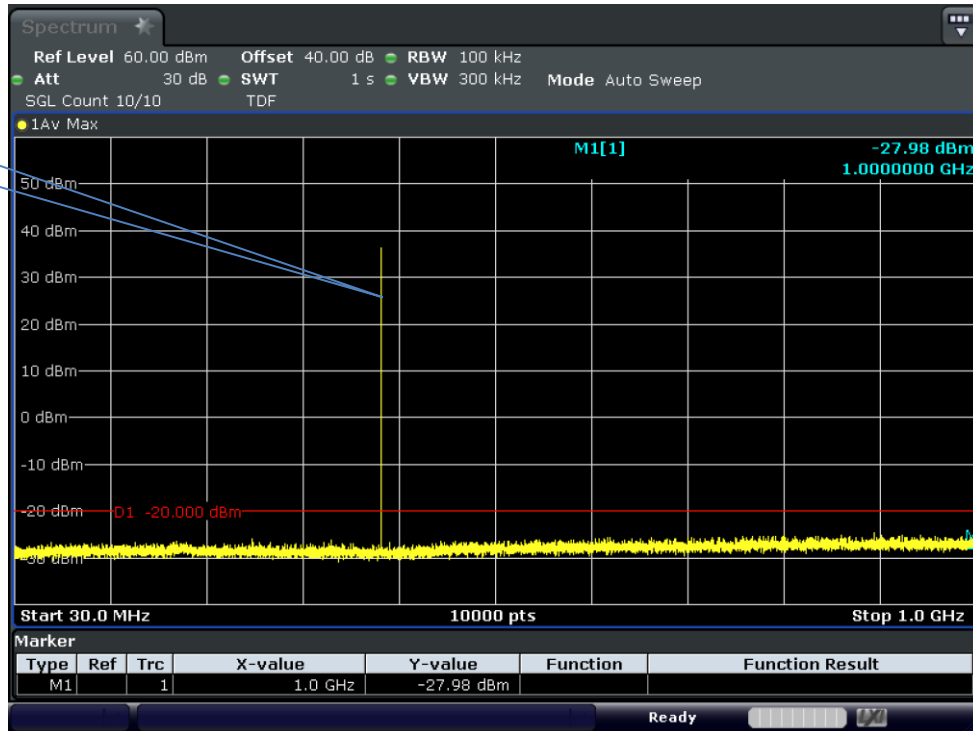


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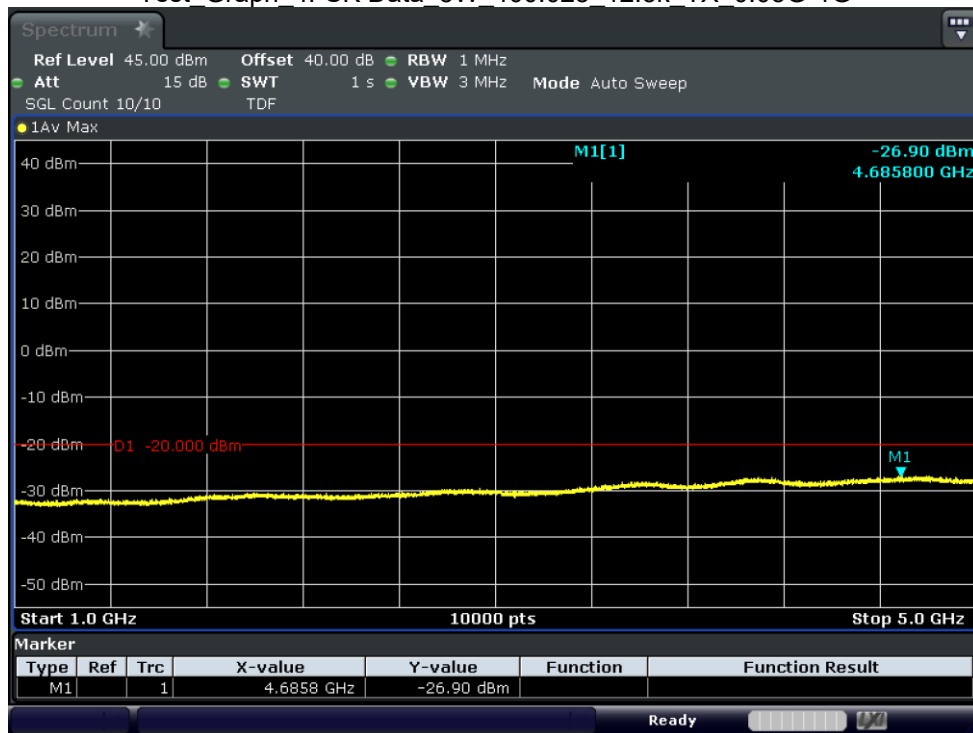




Fundamental



Test Graph 4FSK Data 5W 400.025 12.5k TX 0.03G-1G

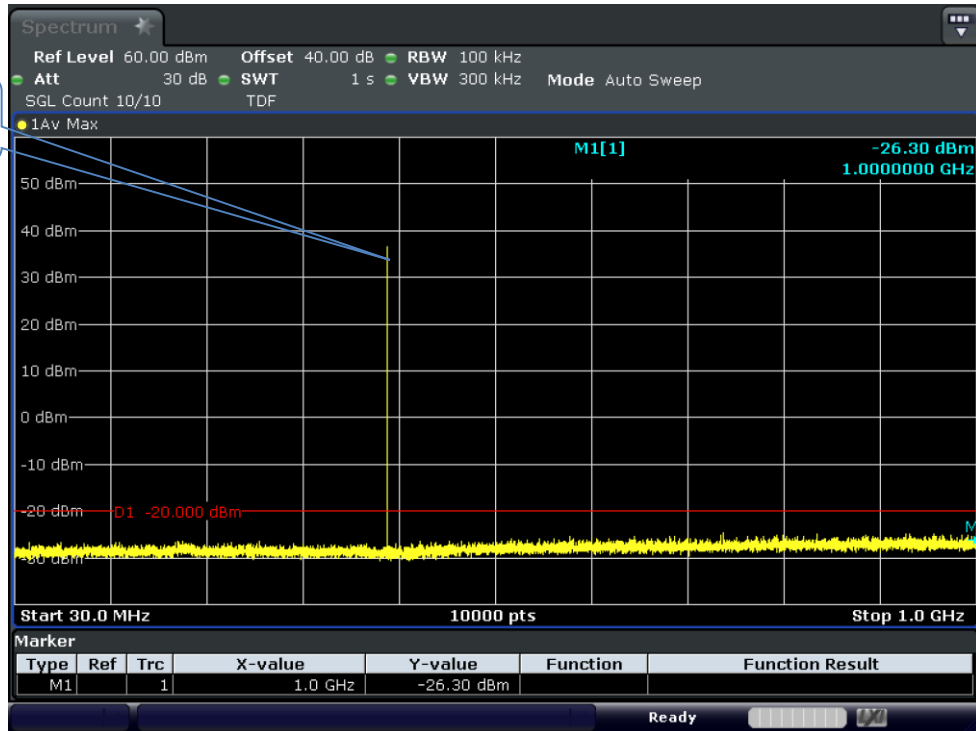


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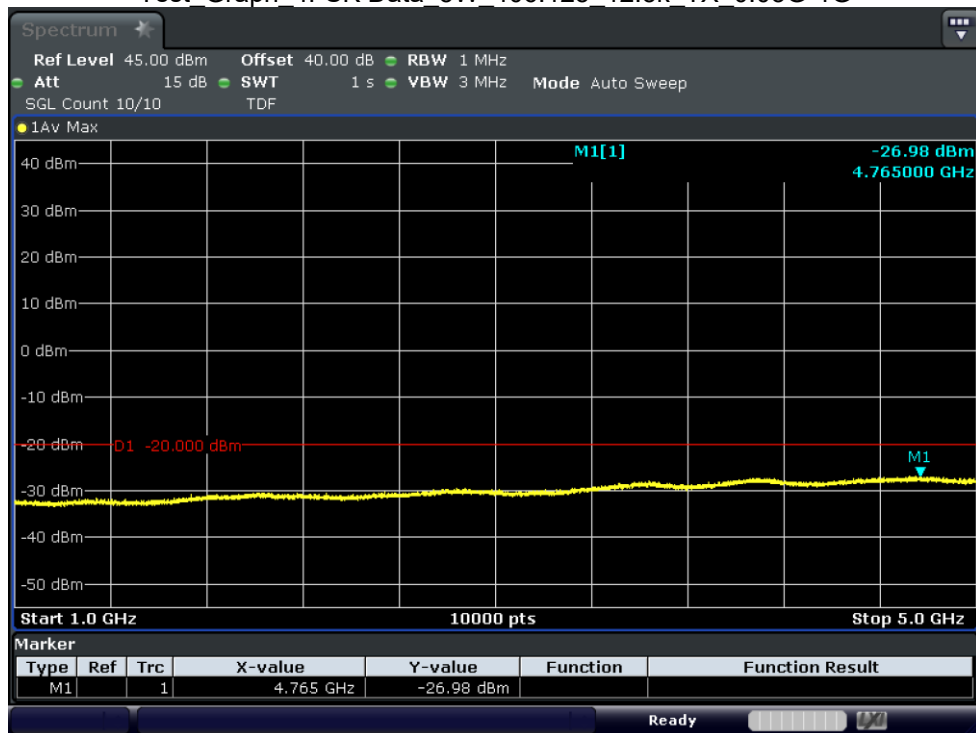




Fundamental



Test Graph 4FSK Data 5W 406.125 12.5k TX 0.03G-1G

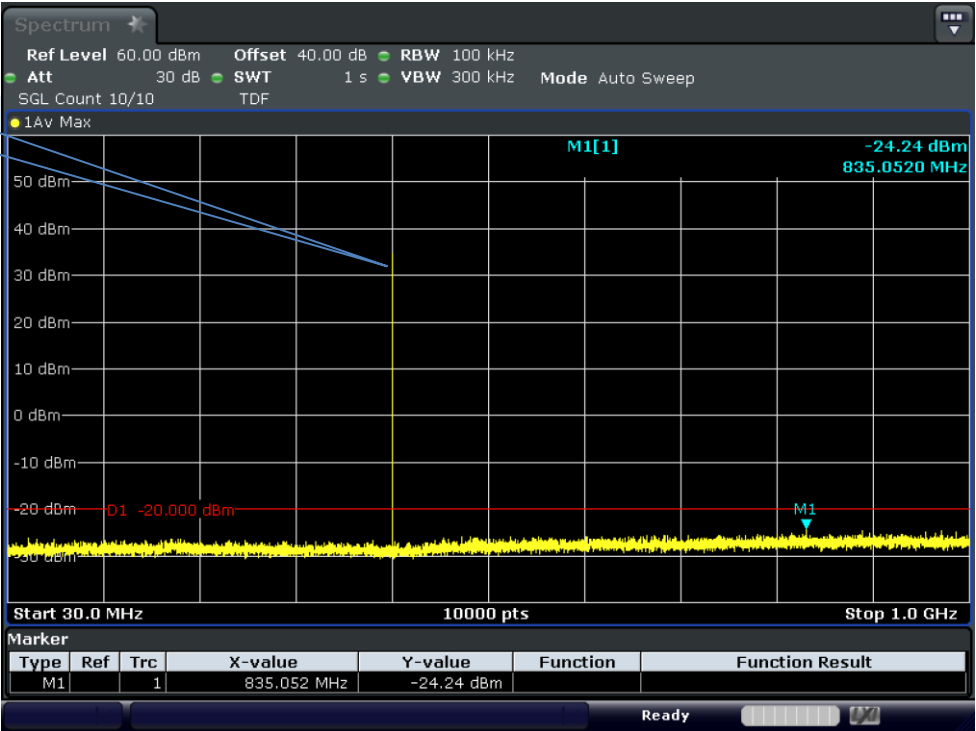


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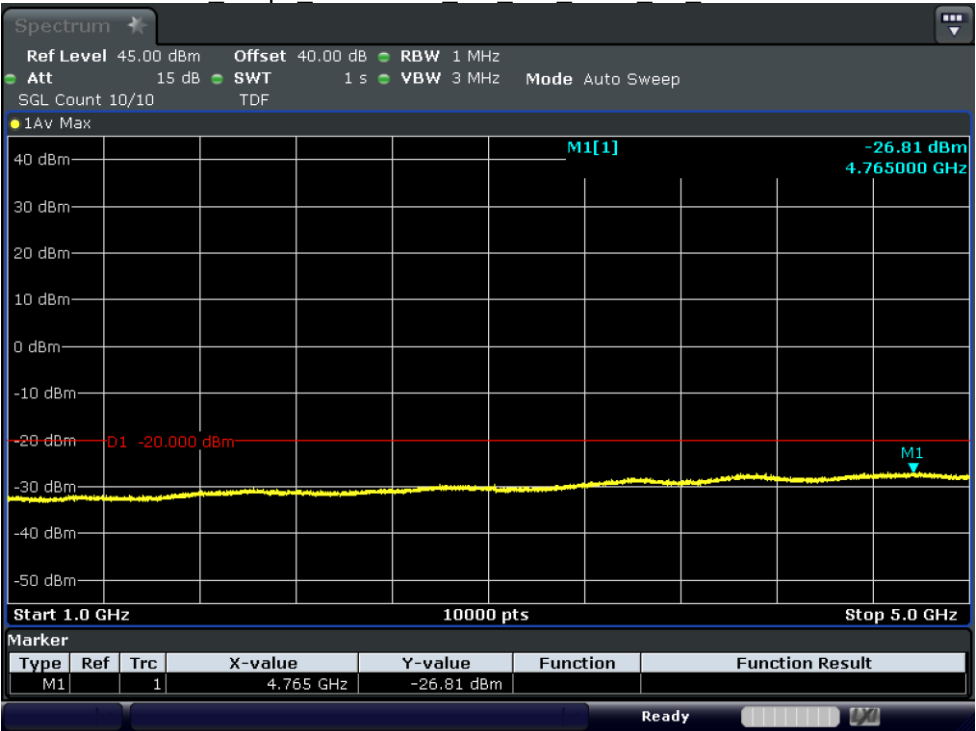




Fundamental



Test Graph 4FSK Data 5W 418 12.5k TX 0.03G-1G

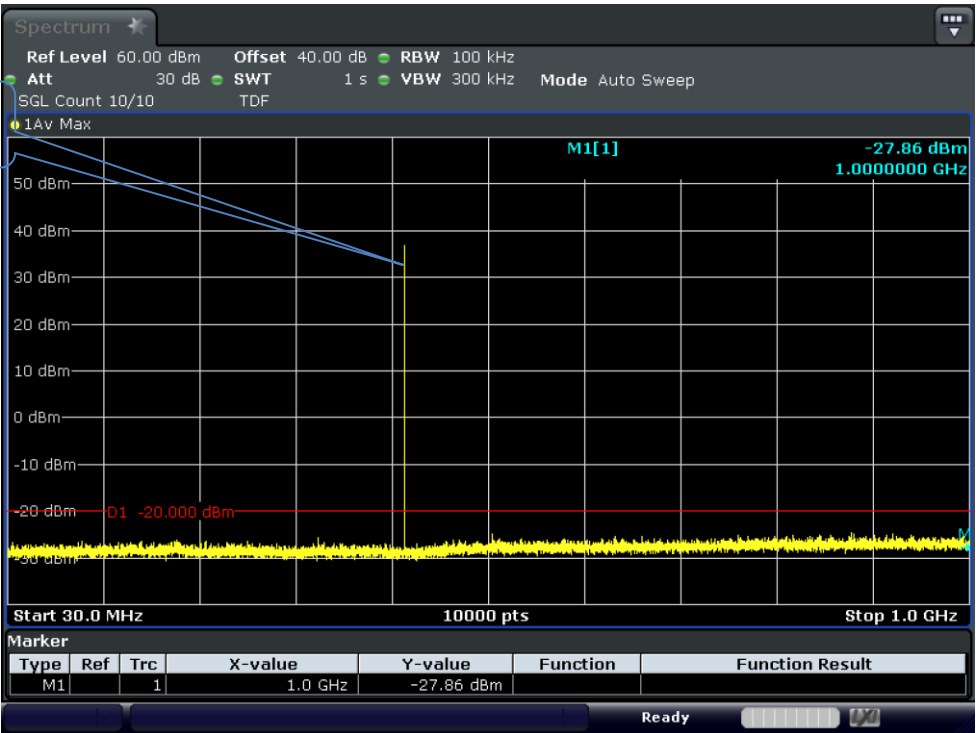


Test_Graph_4FSK Data_5W_418_12.5k_TX_1G-5G

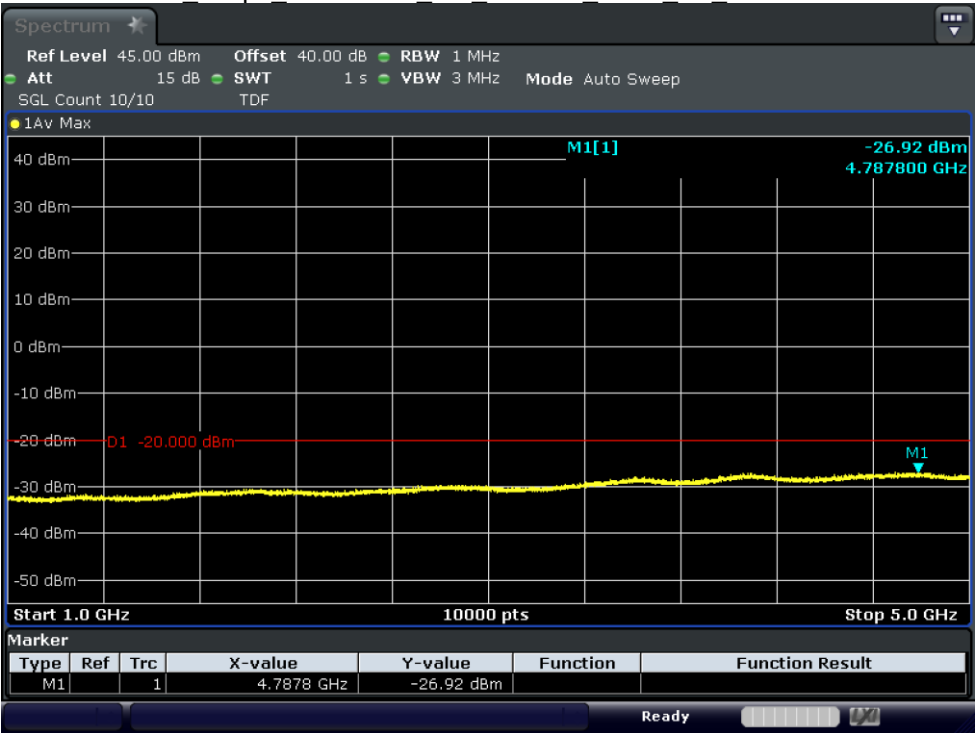




Fundamental



Test Graph 4FSK Data 5W 429.975 12.5k TX 0.03G-1G

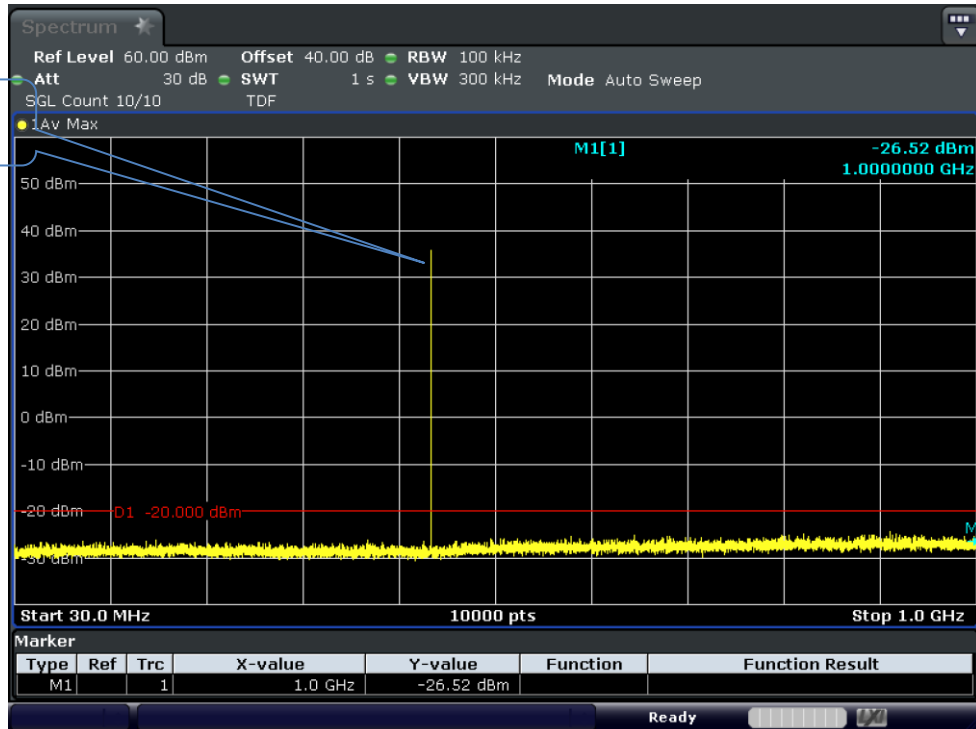


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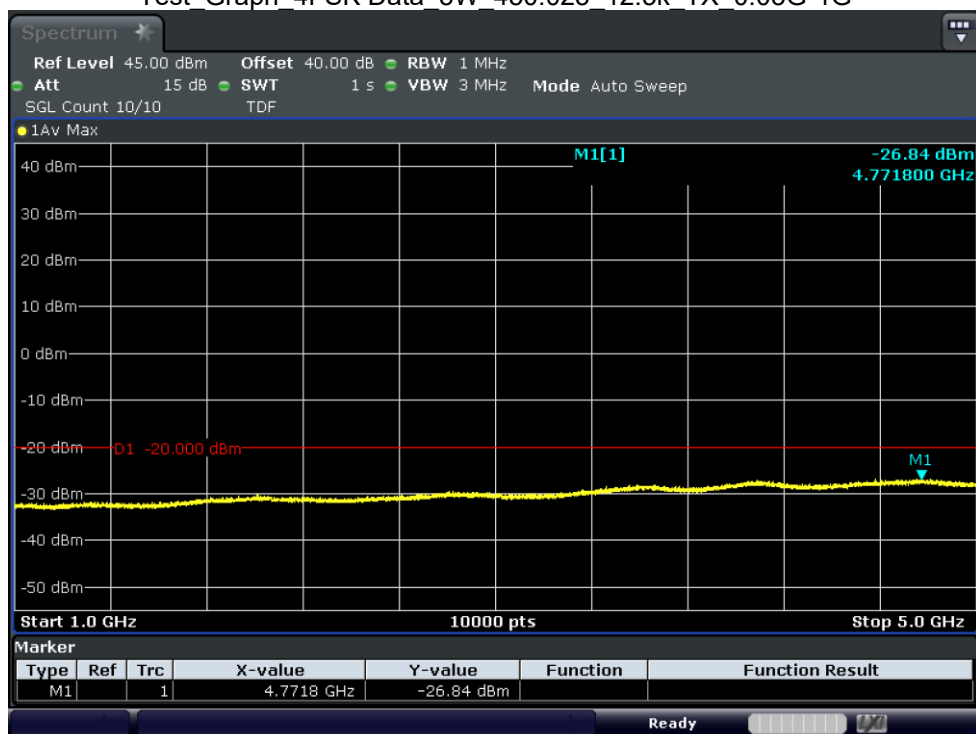




Fundamental



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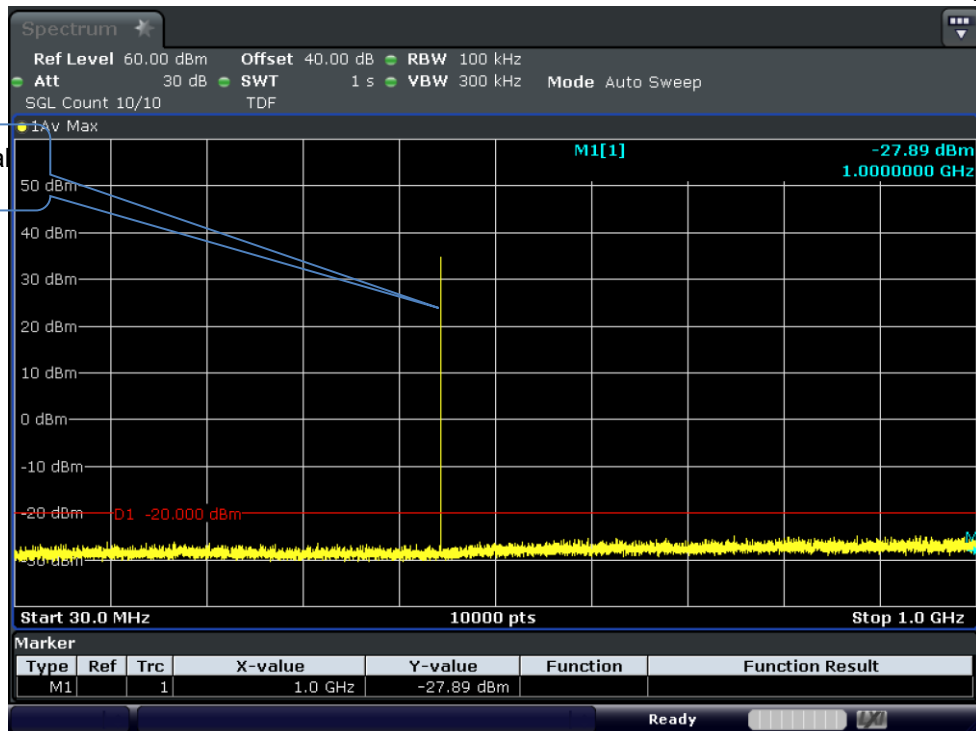


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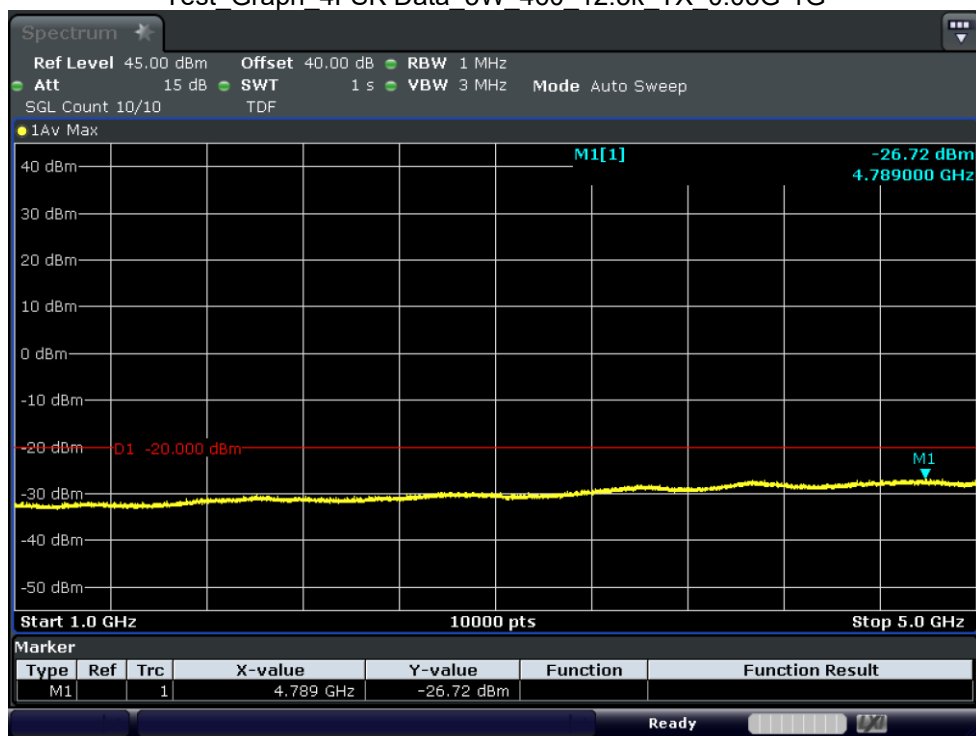




Fundamenta



Test Graph 4FSK Data 5W 460 12.5k TX 0.03G-1G

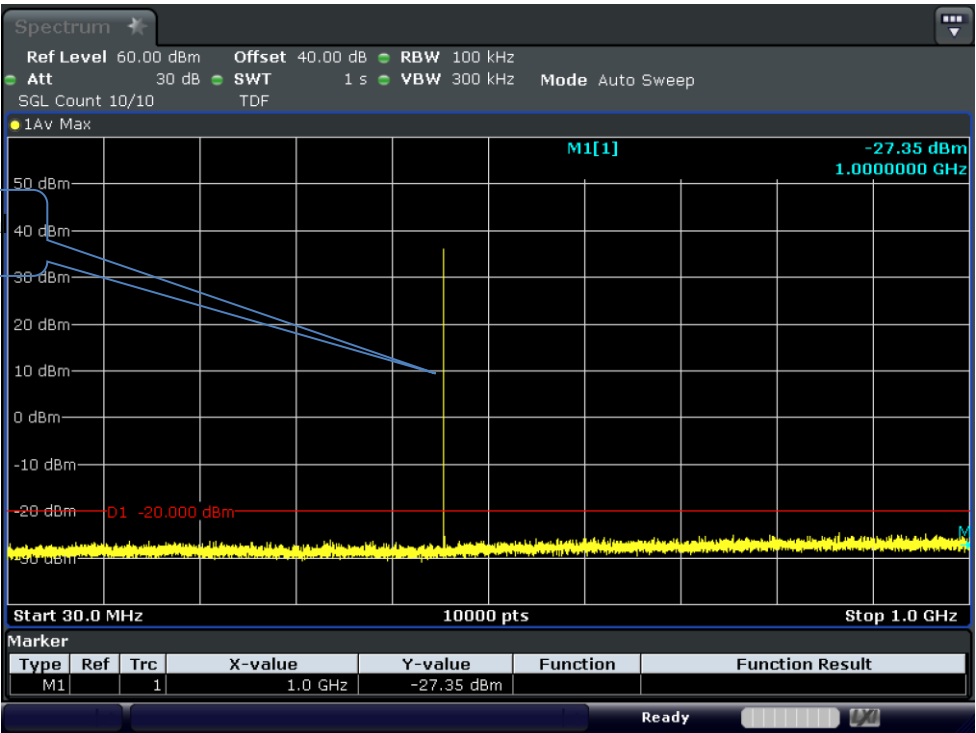


Test_Graph_4FSK Data_5W_460_12.5k_TX_1G-5G

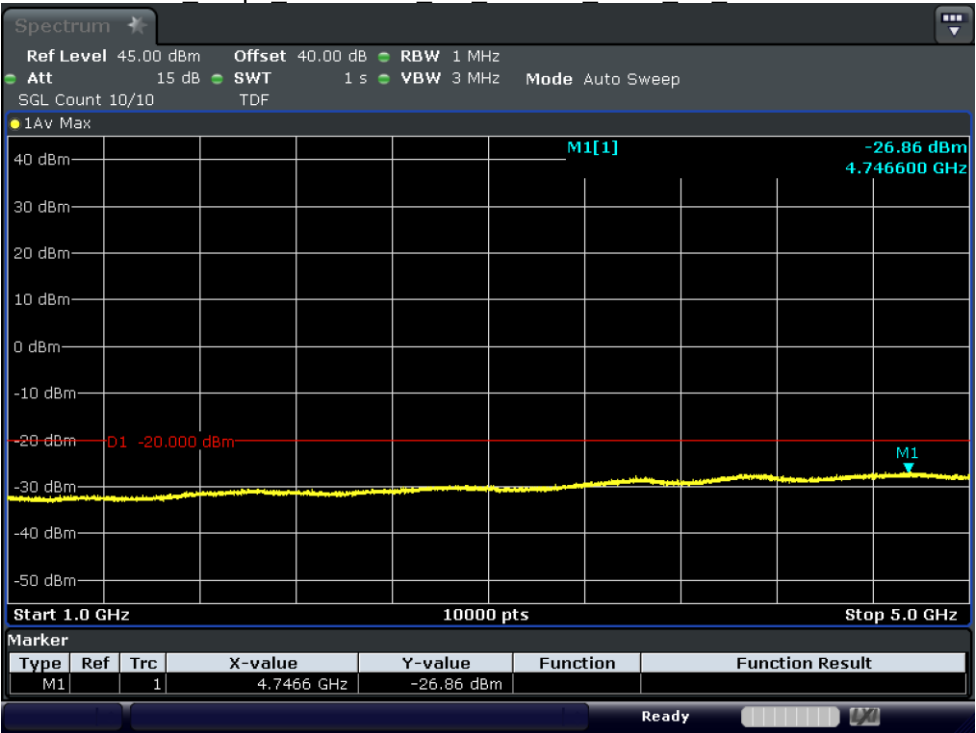




Fundamenta



Test Graph 4FSK Data 5W 469.975 12.5k TX 0.03G-1G



Test_Graph_4FSK Data_5W_469.975_12.5k_TX_1G-5G

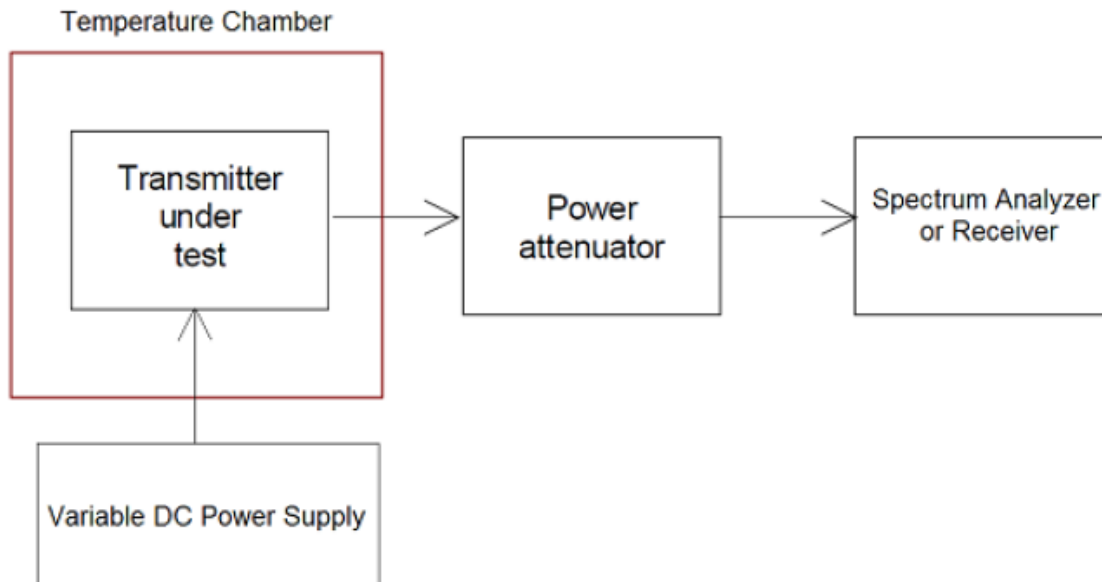
Note: All the test modes was tested, but only the worst mode(4FSK Data) be recorded in this part.





4.6. Frequency Stability

TEST CONFIGURATION



TEST PROCEDURE

The EUT was set in the climate chamber and connected to an external DC power supply. The RF output was directly connected to frequency meter. The coupling loss of the additional cables was recorded and taken in account for all the measurements. After temperature stabilization (approx. 20 min for each stage), the frequency for the lower, the middle and the highest frequency range was recorded. For Frequency stability Vs. Voltage the EUT was connected to a DC power supply and the voltage was adjusted in the required ranges. The result was recorded.

TEST APPLICABLE

- 1 According to FCC Part 2 Section 2.1055 (a)(1), the frequency stability shall be measured with variation of ambient temperature from -30°C to +60°C centigrade.
- 2 According to FCC Part 2 Section 2.1055 (a) (2), for battery powered equipment, the frequency stability shall be measured with reducing primary supply voltage to the battery operating end point, which is specified by the manufacture.
- 3 Vary primary supply voltage from 85 to 115 percent of the nominal value; if manufacturer declares extreme voltage within 85 to 115 percent of the nominal value, measured at extreme voltage declared by manufacturer.

LIMIT

2.5 ppm.





TEST RESULTS

Test conditions		Frequency error (ppm)		
Voltage Condition	Temp(°C)	400.025 MHz	450.025MHz	469.975MHz
NV	-30	0.128	0.128	0.128
	-20	0.128	0.128	0.128
	-10	0.128	0.128	0.128
	0	0.128	0.128	0.128
	10	0.128	0.128	0.128
	20	0.128	0.128	0.128
	30	0.128	0.128	0.128
	40	0.133	0.134	0.134
	50	0.133	0.134	0.134
LV	20	0.128	0.128	0.128
HV	20	0.128	0.128	0.128
Limit(ppm)		2.50	2.50	2.50
Result		PASS	PASS	PASS

Note: All the test modes was tested, but only the worst mode(25W power level at 400.025MHz/450.025MHz/469.975MHz) be recorded in this part.

NV: Normal Voltage 14.80V

LV: Low Voltage 12.58V

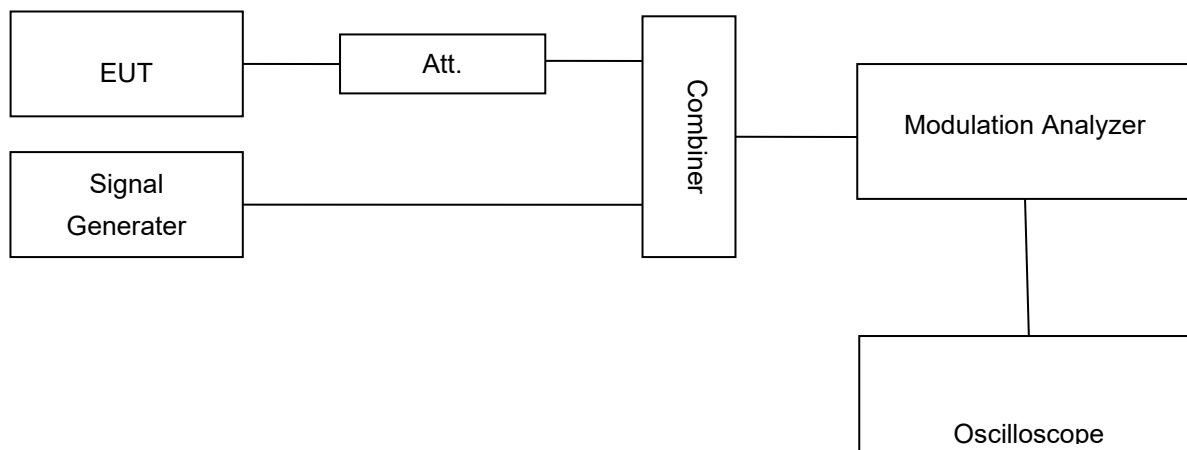
HV: High Voltage 17.02V





4.7. Transient Frequency Behavior

TEST CONFIGURATION



TEST PROCEDURE

1. Connect the EUT and test equipment as shown on the following block diagram.
2. Set the Spectrum Analyzer to measure FM deviation, and tune the RF frequency to the transmitter assigned frequency.
3. Set the signal generator to the assigned transmitter frequency and modulate it with a 1 kHz tone at ± 12.5 kHz deviation and set its output level to -100dBm.
4. Turn on the transmitter.
5. Supply sufficient attenuation via the RF attenuator to provide an input level to the Spectrum Analyzer that is 40 dB below the maximum allowed input power when the transmitter is operating at its rated power level. Note this power level on the Spectrum Analyzer as P0.
6. Turn off the transmitter.
7. Adjust the RF level of the signal generator to provide RF power equal to P0. This signal generator RF level shall be maintained throughout the rest of the measurement.
8. Remove the attenuation 1, so the input power to the Spectrum Analyzer is increased by 30 dB when the transmitter is turned on.
9. Adjust the vertical amplitude control of the spectrum analyzer to display the 1000 Hz at ± 4 divisions vertically centered on the display. Set trigger mode of the Spectrum Analyzer to "Video", and tune the "trigger level" on suitable level. Then set the "trigger offset" to -10ms for turn on and -15ms for turn off.
11. Turn on the transmitter and the transient wave will be captured on the screen of Spectrum Analyzer. Observe the stored display. The instant when the 1 kHz test signal is completely suppressed is considered to be t_1 . The trace should be maintained within the allowed divisions during the period t_1 and t_2 .
12. Then turn off the transmitter, and another transient wave will be captured on the screen of Spectrum Analyzer. The trace should be maintained within the allowed divisions during the period t_3 .





LIMIT

Time intervals ^{1, 2}	Maximum frequency difference ³	All equipment	
		150 to 174 MHz	421 to 512 MHz
Transient Frequency Behavior for Equipment Designed to Operate on 25 kHz Channels			
t ₁ ⁴	± 25.0 kHz	5.0 ms	10.0 ms
t ₂	± 12.5 kHz	20.0 ms	25.0 ms
t ₃ ⁴	± 25.0 kHz	5.0 ms	10.0 ms
Transient Frequency Behavior for Equipment Designed to Operate on 12.5 kHz Channels			
t ₁ ⁴	± 12.5 kHz	5.0 ms	10.0 ms
t ₂	± 6.25 kHz	20.0 ms	25.0 ms
t ₃ ⁴	± 12.5 kHz	5.0 ms	10.0 ms
Transient Frequency Behavior for Equipment Designed to Operate on 6.25 kHz Channels			
t ₁ ⁴	± 6.25 kHz	5.0 ms	10.0 ms
t ₂	± 3.125 kHz	20.0 ms	25.0 ms
t ₃ ⁴	± 6.25 kHz	5.0 ms	10.0 ms

¹ t_{on} is the instant when a 1 kHz test signal is completely suppressed, including any capture time due to phasing.

t₁ is the time period immediately following t_{on}.

t₂ is the time period immediately following t₁.

t₃ is the time period from the instant when the transmitter is turned off until t_{off}.

t_{off} is the instant when the 1 kHz test signal starts to rise.

² During the time from the end of t₂ to the beginning of t₃, the frequency difference must not exceed the limits specified in §90.213.

³ Difference between the actual transmitter frequency and the assigned transmitter frequency.

⁴ If the transmitter carrier output power rating is 6 watts or less, the frequency difference during this time period may exceed the maximum frequency difference for this time period.

TEST RESULTS

Not Applicable





5. TEST SETUP PHOTOGRAPHS OF EUT

Please refer to separated files for Test Setup Photos of the EUT.

6. EXTERIOR PHOTOGRAPHS OF EUT

Please refer to separated files for External Photos of the EUT.

7. INTERIOR PHOTOGRAPHS OF EUT

Please refer to separated files for Internal Photos of the EUT.

.....**End of Report**.....

